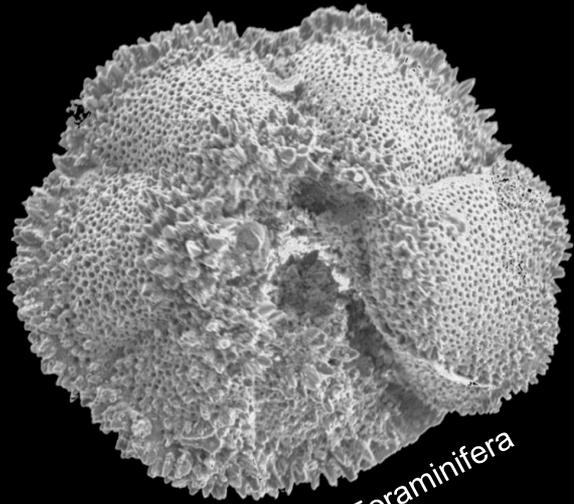
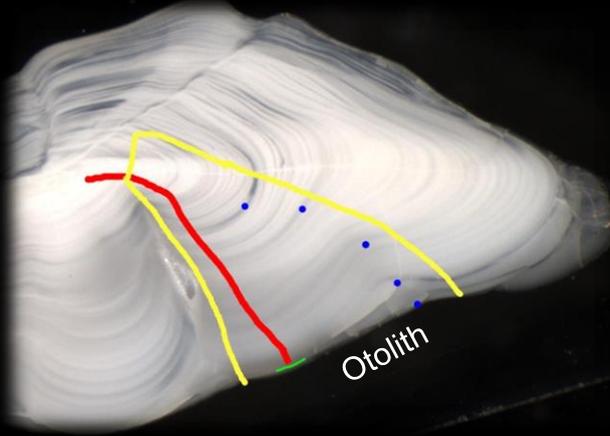


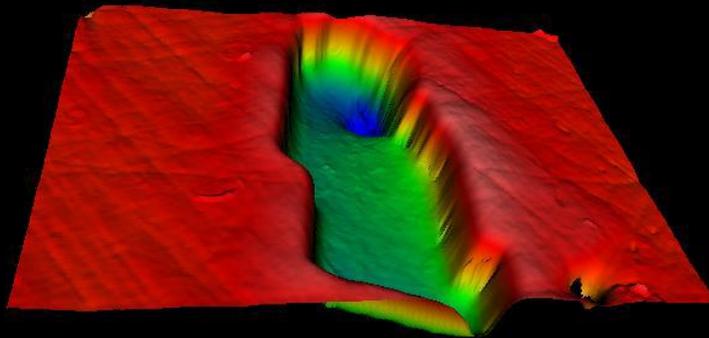
Carbon and Oxygen Isotope Analyses in Biocarbonates by SIMS



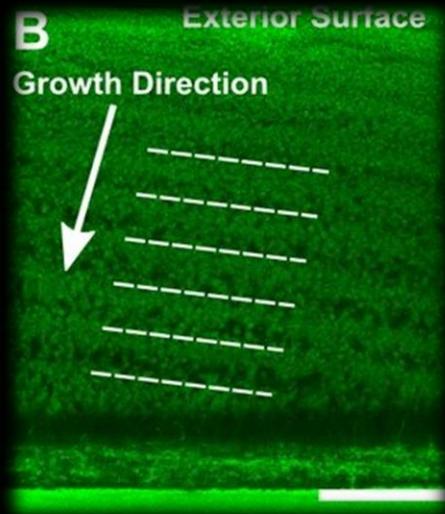
Foraminifera



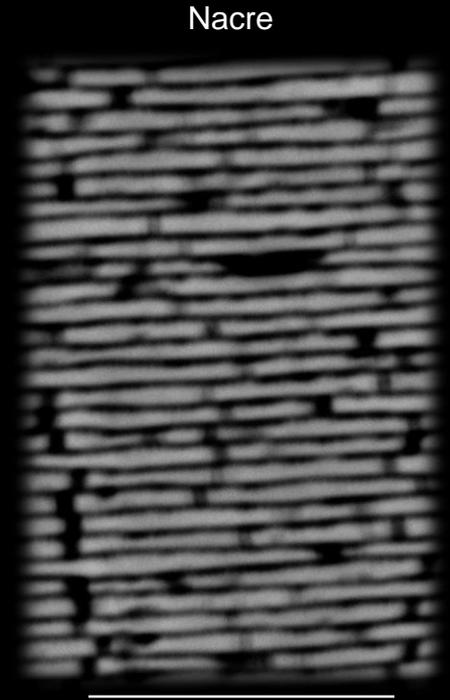
Otolith



3D image of polished otolith



Confocal Laser Fluorescent Microscopy Image of a Nautilus shell cross section



Nacre

5 μ m



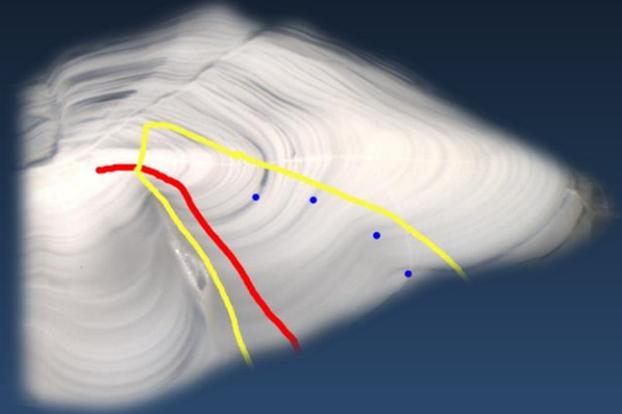
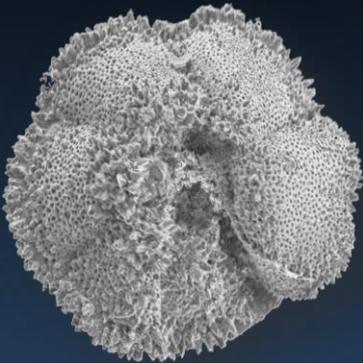
Reinhard Kozdon
Ian J. Orland, Noriko T. Kita, John W. Valley

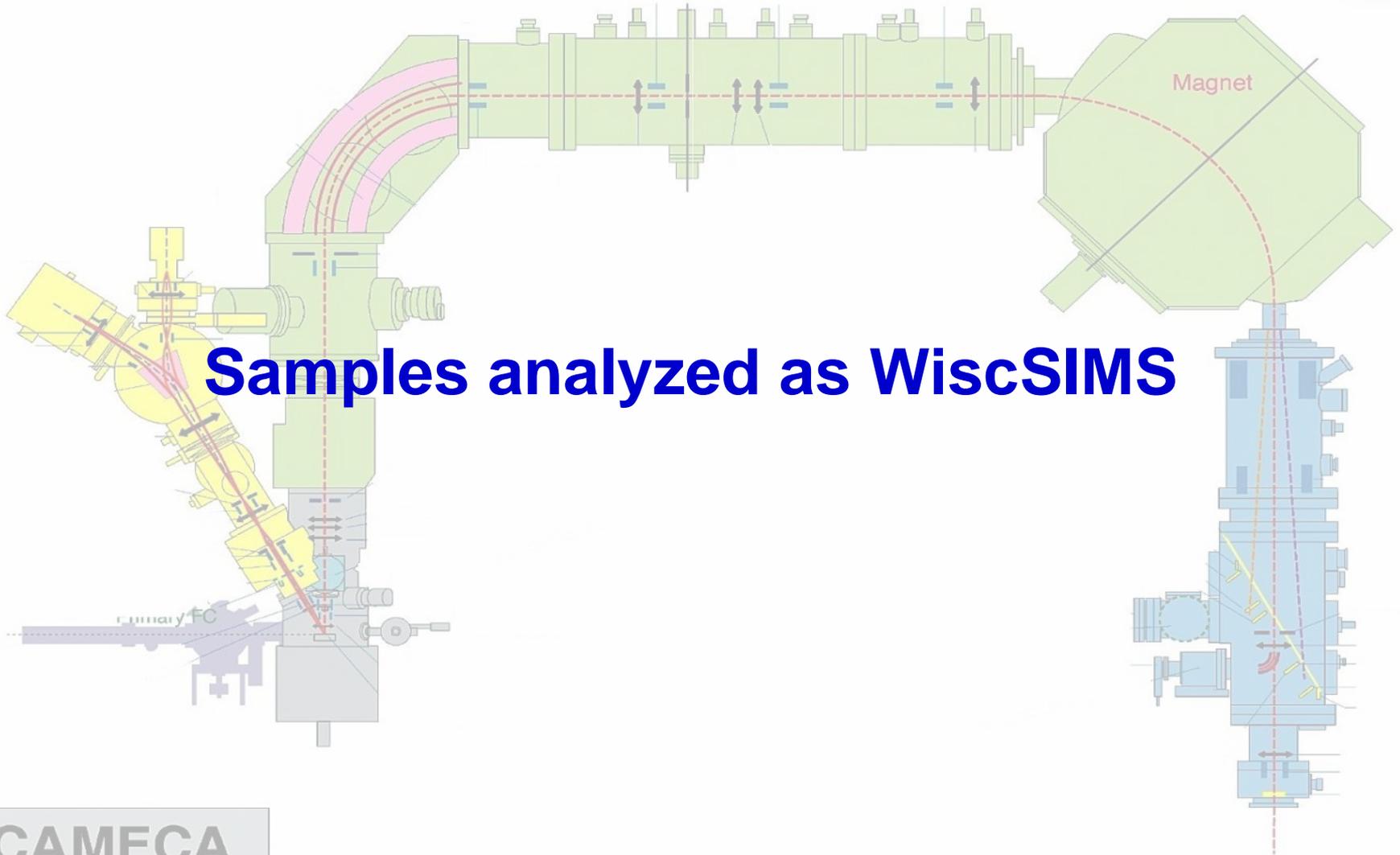


$\delta^{18}\text{O}$ and $\delta^{13}\text{C}$ in biocarbonates by SIMS

Carbonate samples analyzed at WiscSIMS:

- foraminiferal shells
- speleothems
- nautilus shells
- mollusk shells
- fish otoliths
- corals



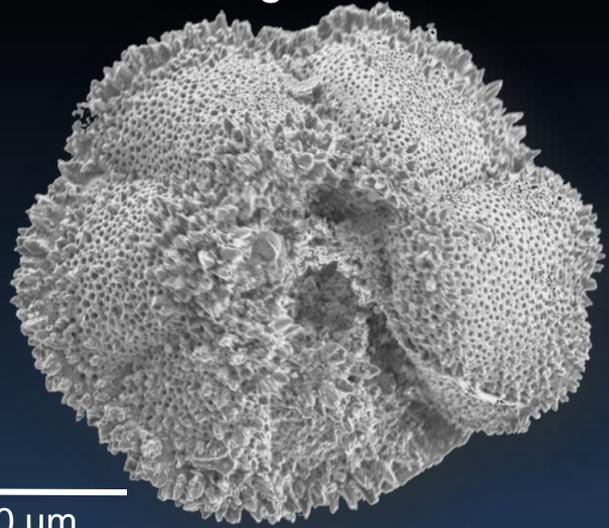


Samples analyzed as WiscSIMS

CAMECA

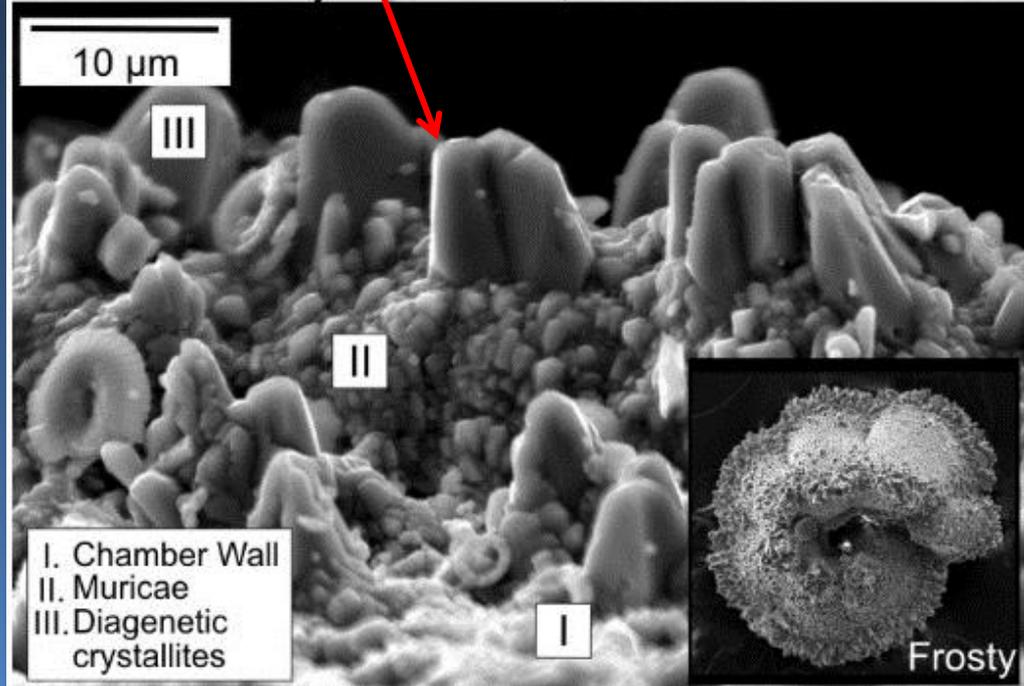
IMS 1280

Identification of diagenetic calcite in foraminiferal shells – reassessment of paleorecords



100 μm

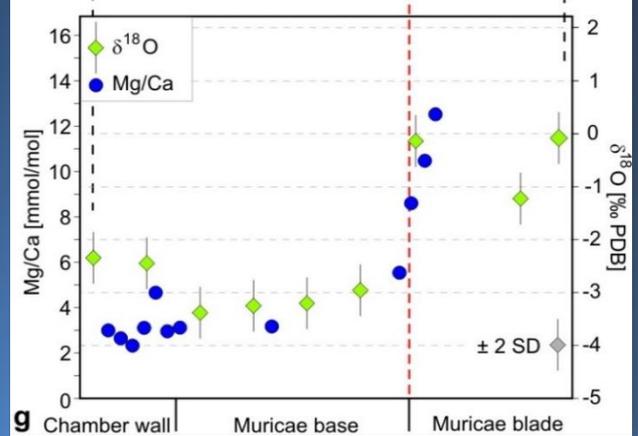
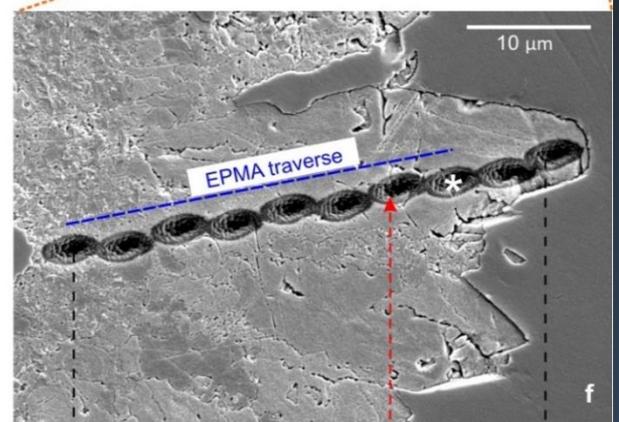
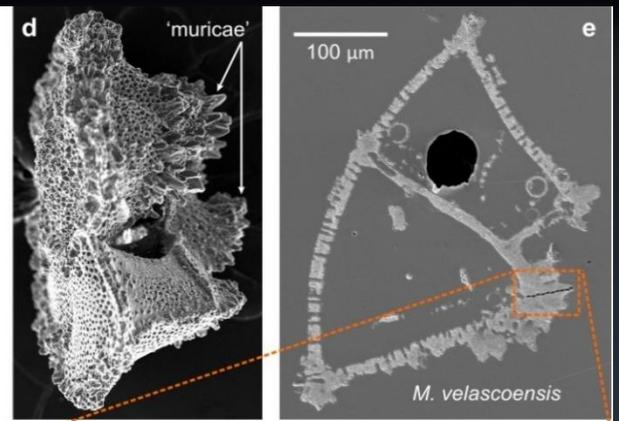
Frosty morzovellid, ODP Site 865



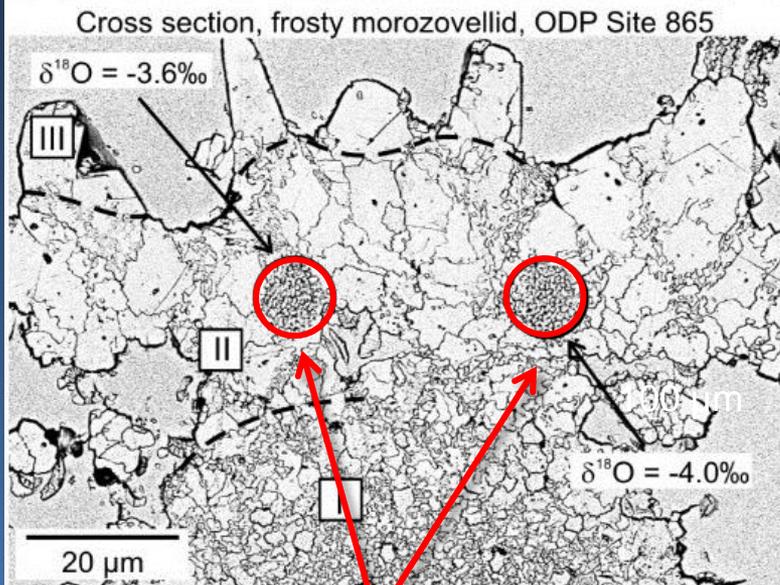
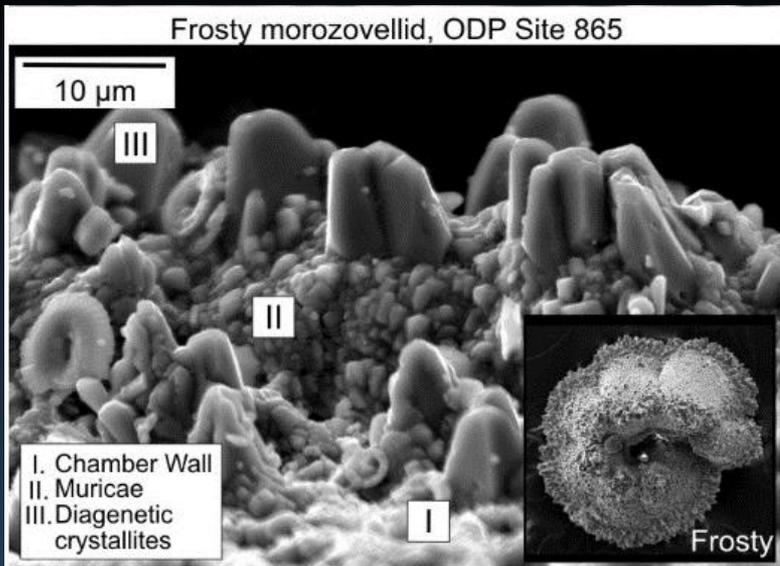
10 μm

- I. Chamber Wall
- II. Muricae
- III. Diagenetic crystallites

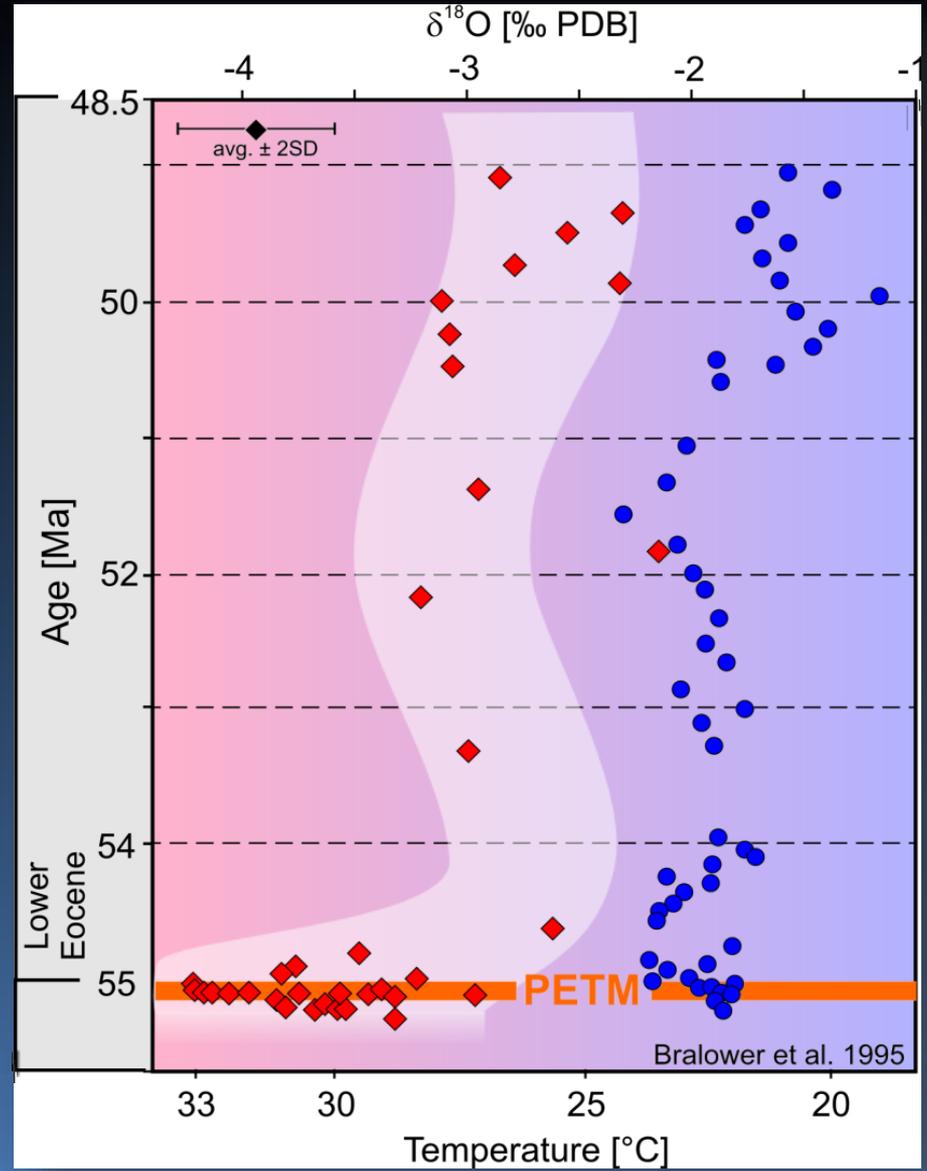
Frosty



Identification of diagenetic calcite in foraminiferal shells – reassessment of paleorecords

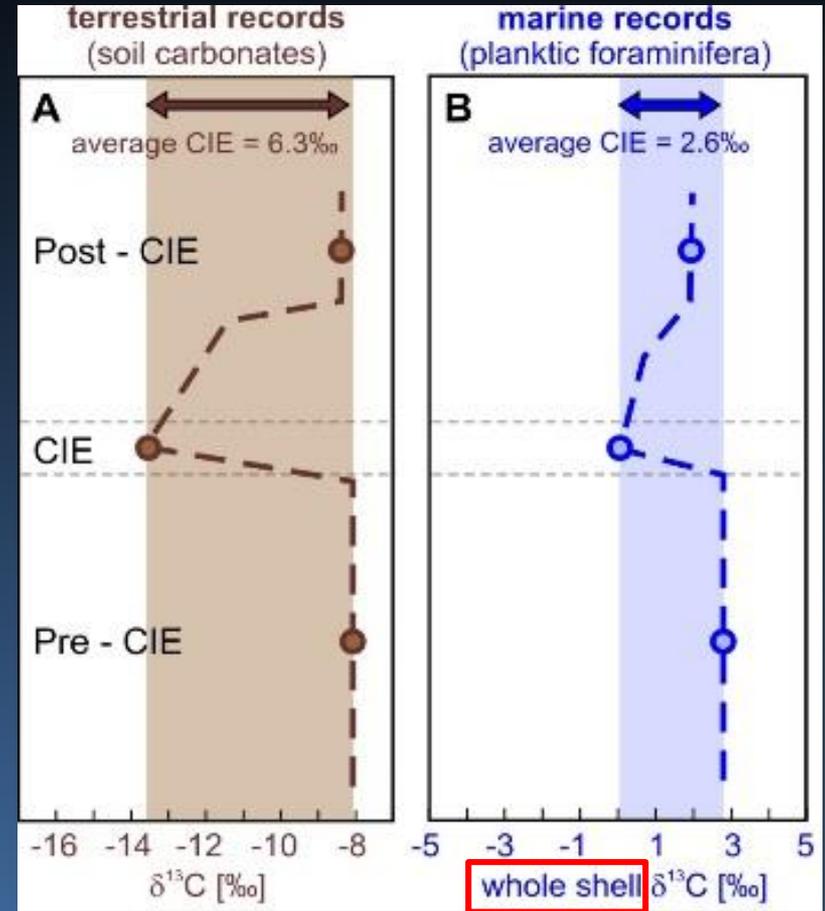
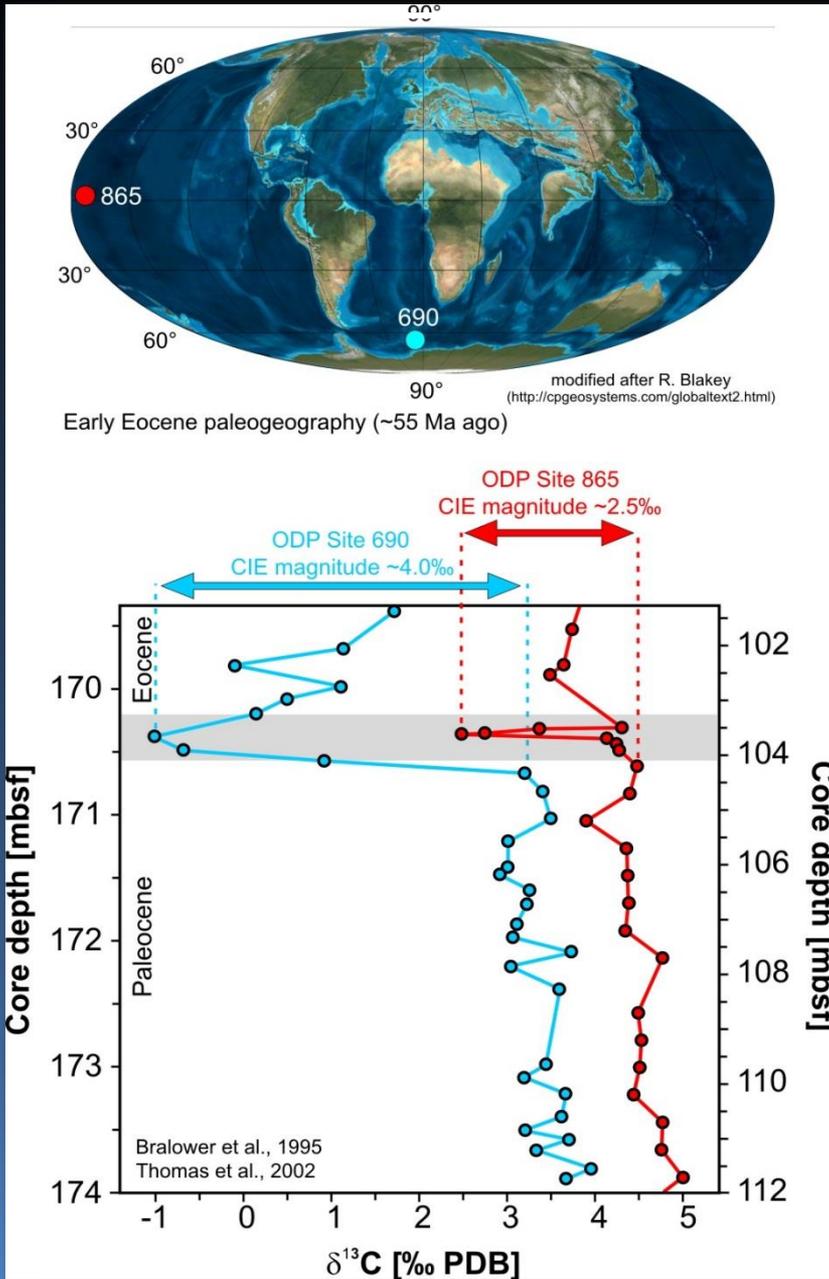


$\delta^{18}\text{O}$ measurements by SIMS in **alteration-resistant** domains



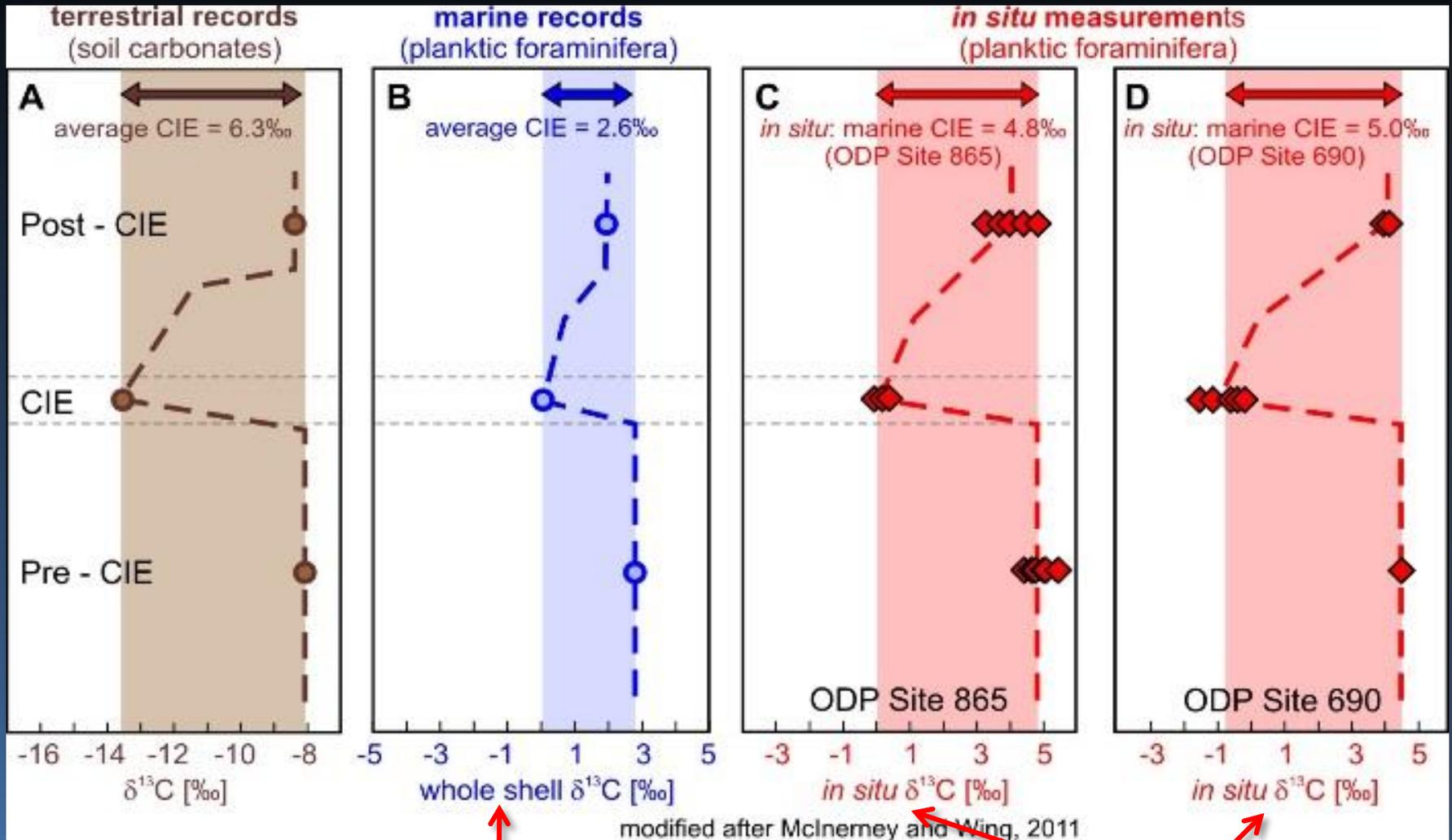
Kozdon et al. 2011

Magnitude of the Carbon Isotope Excursion (CIE) in the marine record



Modified after McNerney and Wing, 2012

Magnitude of the Carbon Isotope Excursion (CIE) in the marine record

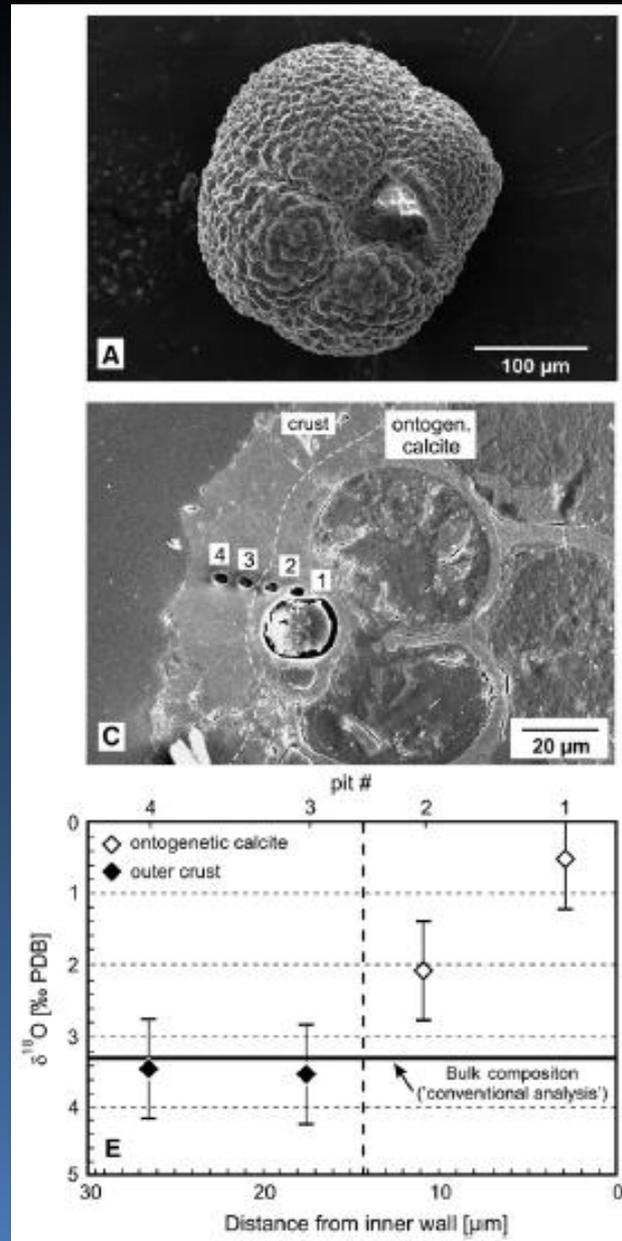


whole shells

$\delta^{13}\text{C}$ measurements by SIMS in alteration-resistant domains

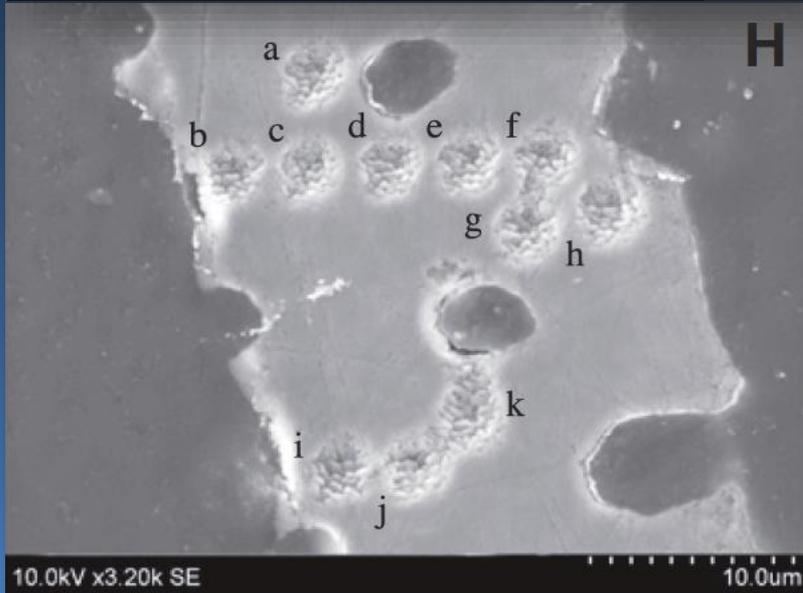
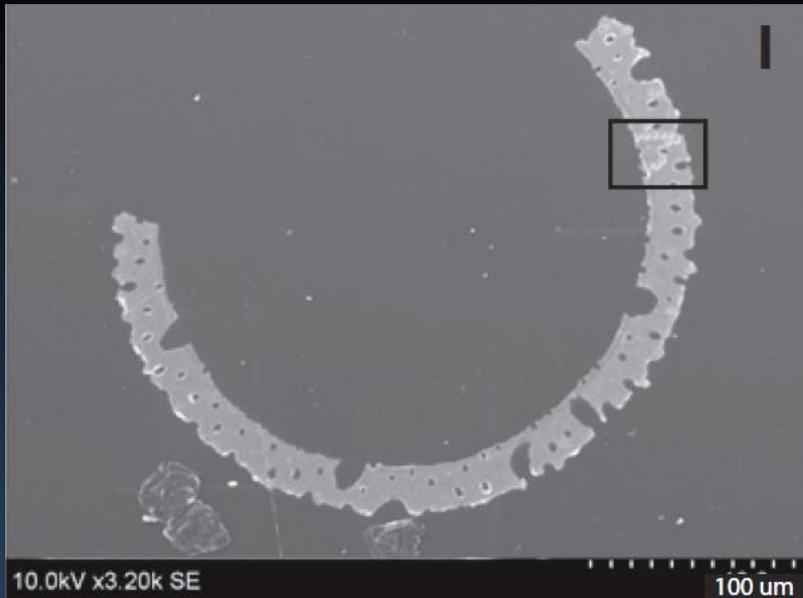
Kozdon et al., in prep.

Intrashell $\delta^{18}\text{O}$ variability in foraminiferal shells

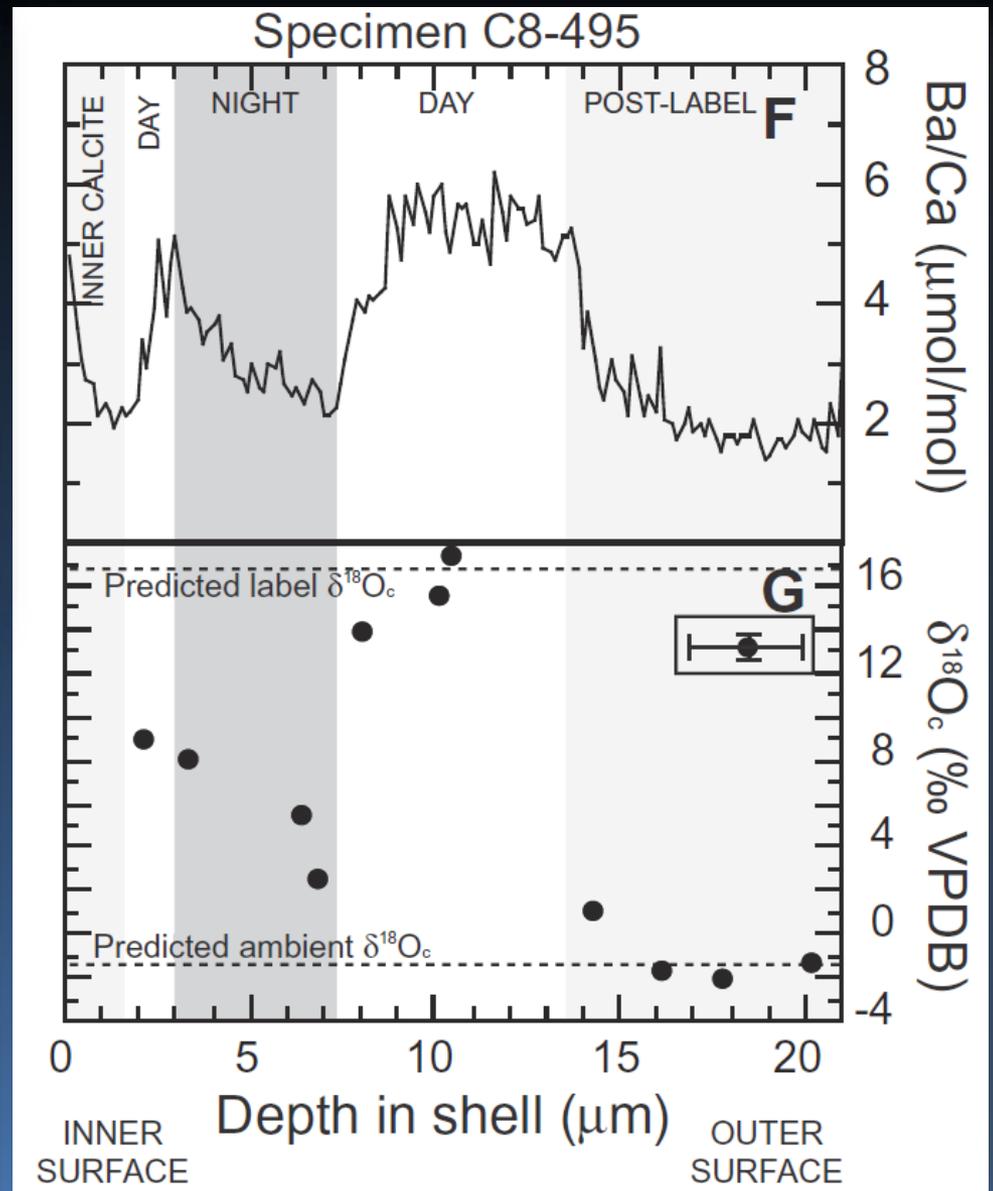


Kozdon et al., 2009

Measurements of daily growth increments in foraminiferal shells



Vetter et al. 2013



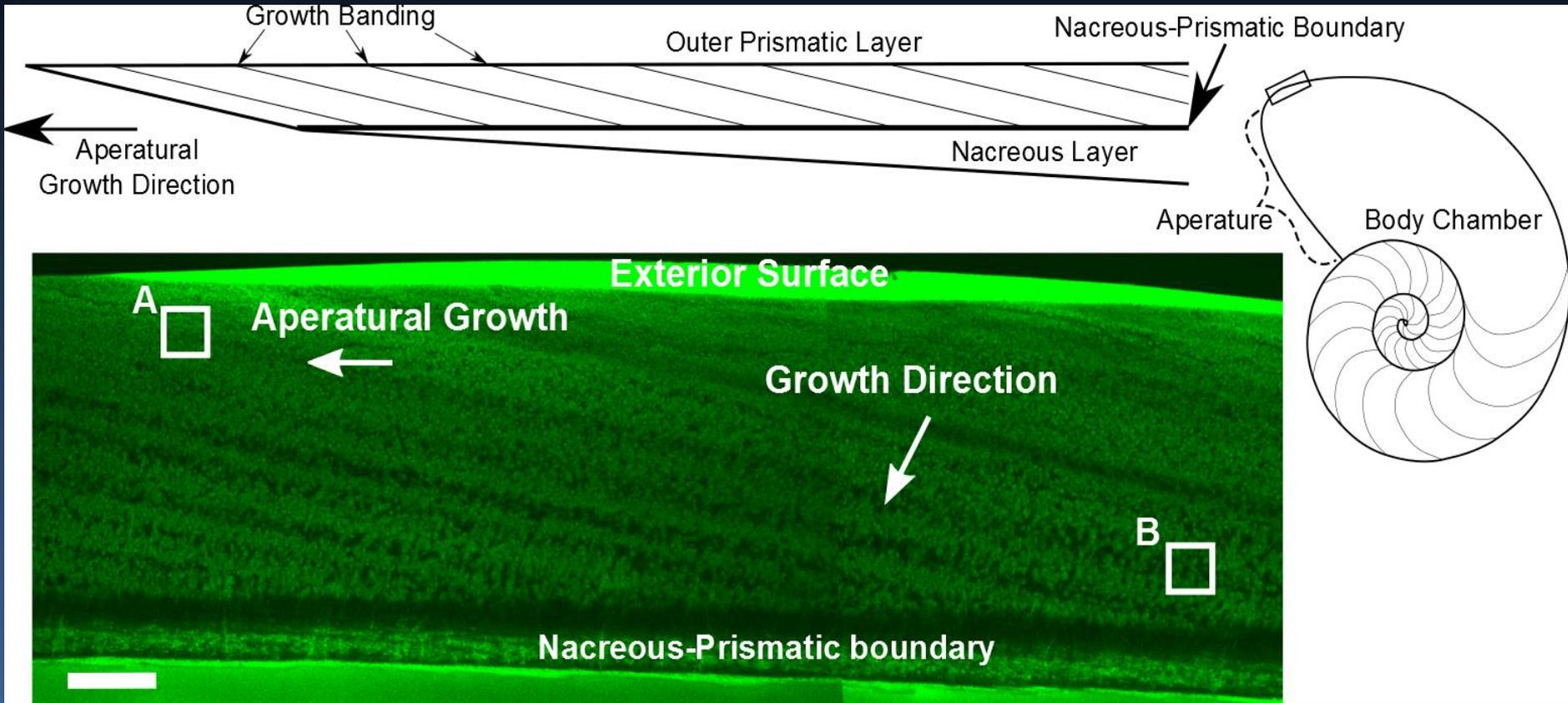
Vetter et al. 2013

Nautilus macromphalus



Wild-caught *Nautilus macromphalus*
from New Caledonia

Nautilus shell

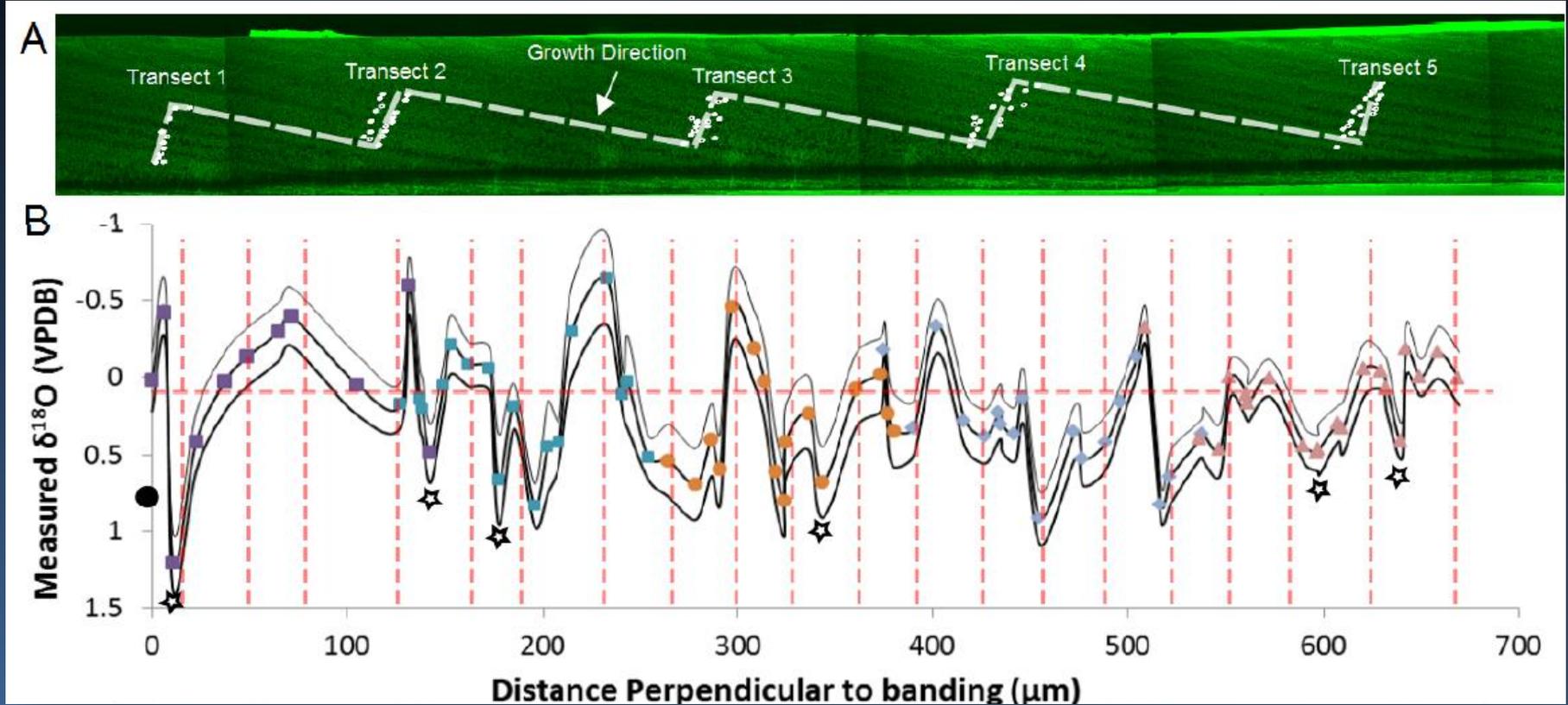


confocal laser fluorescence microscopy

Linzmeier et al., in prep.

Nautilus shell

One half centimeter (~20 days of growth) of Nautilus shell



Linzmeier et al., in prep.

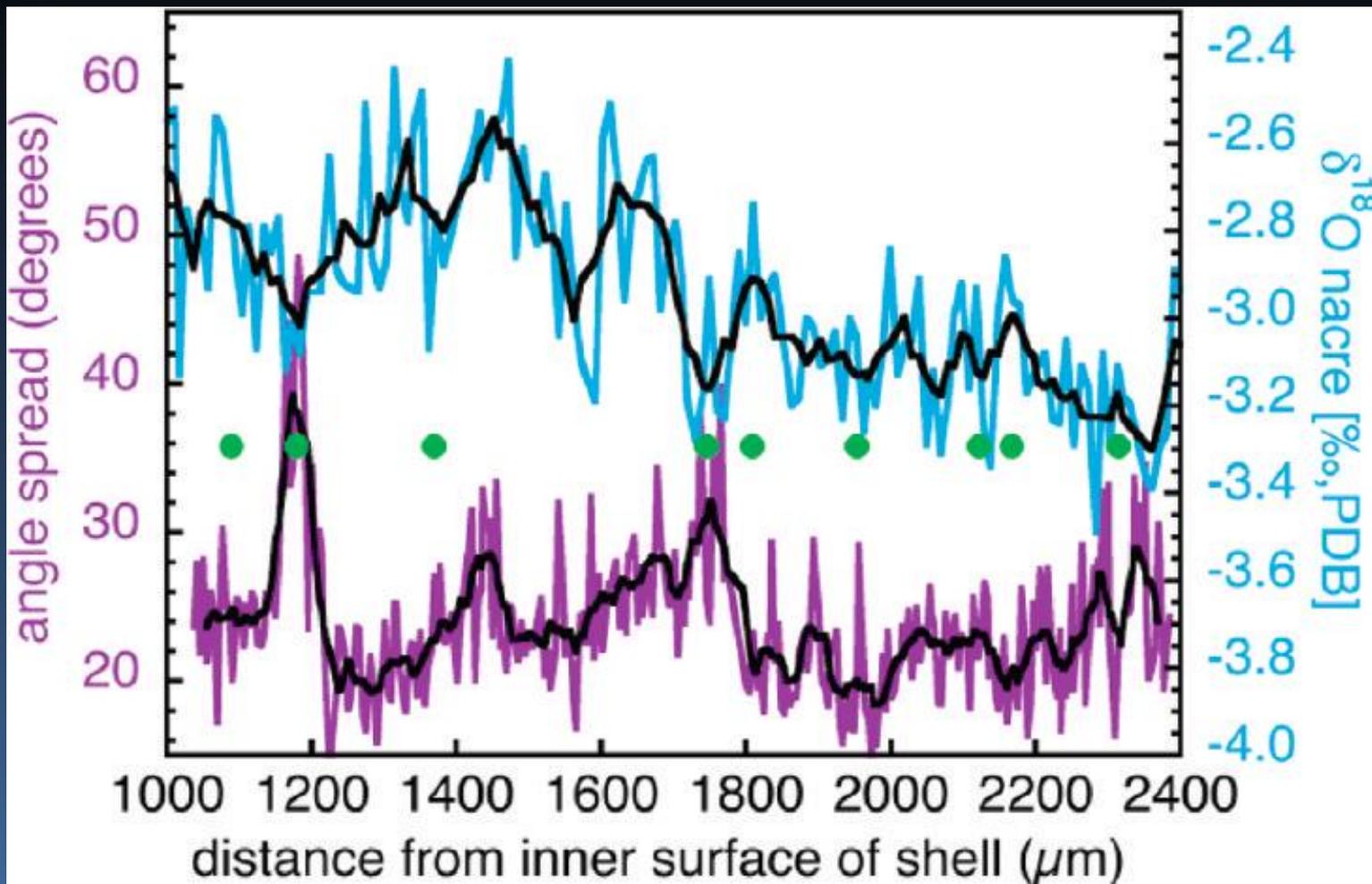
Mollusk shells

Tahitian black
pearl oyster



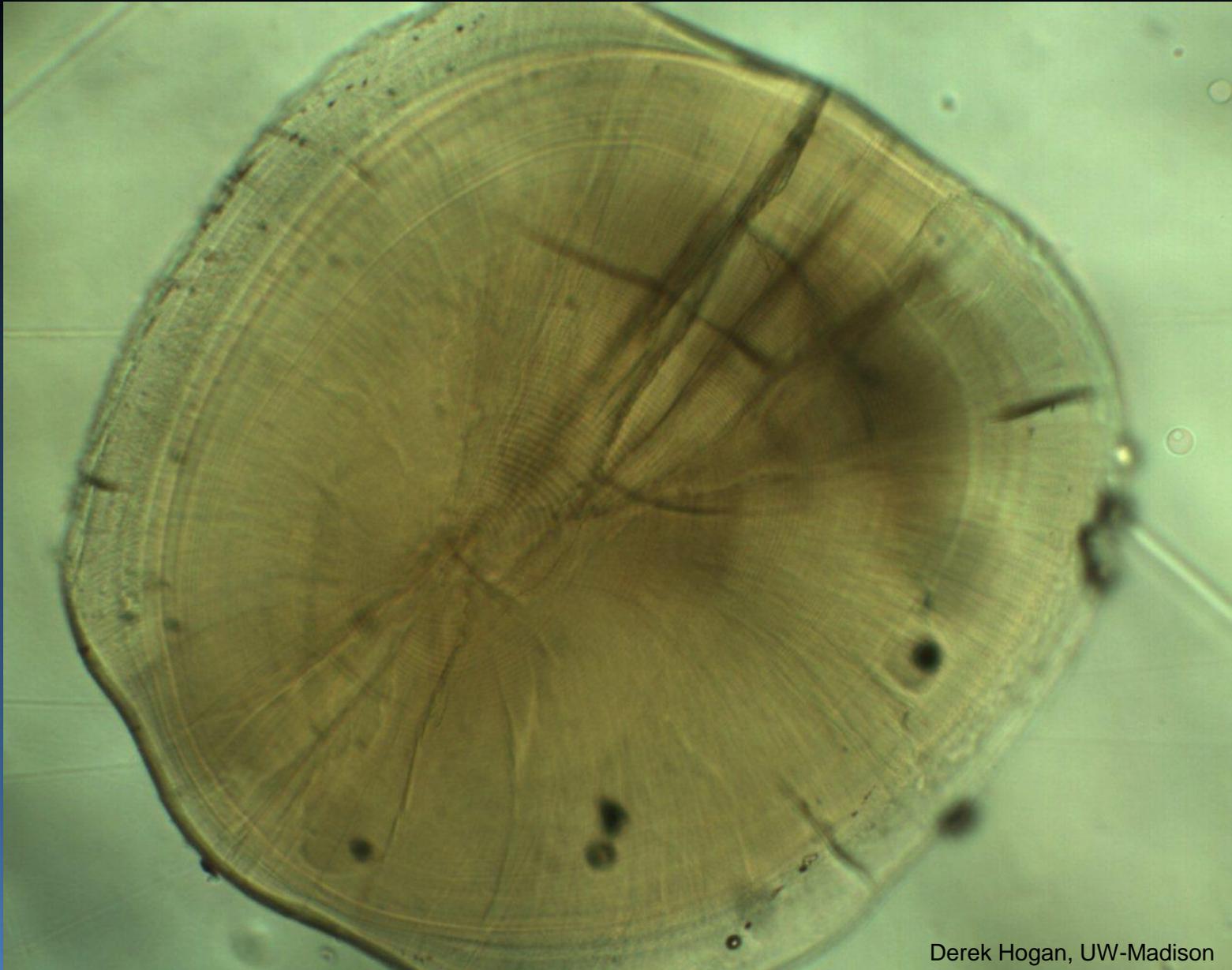
Olson et al. 2012

Mollusk shells



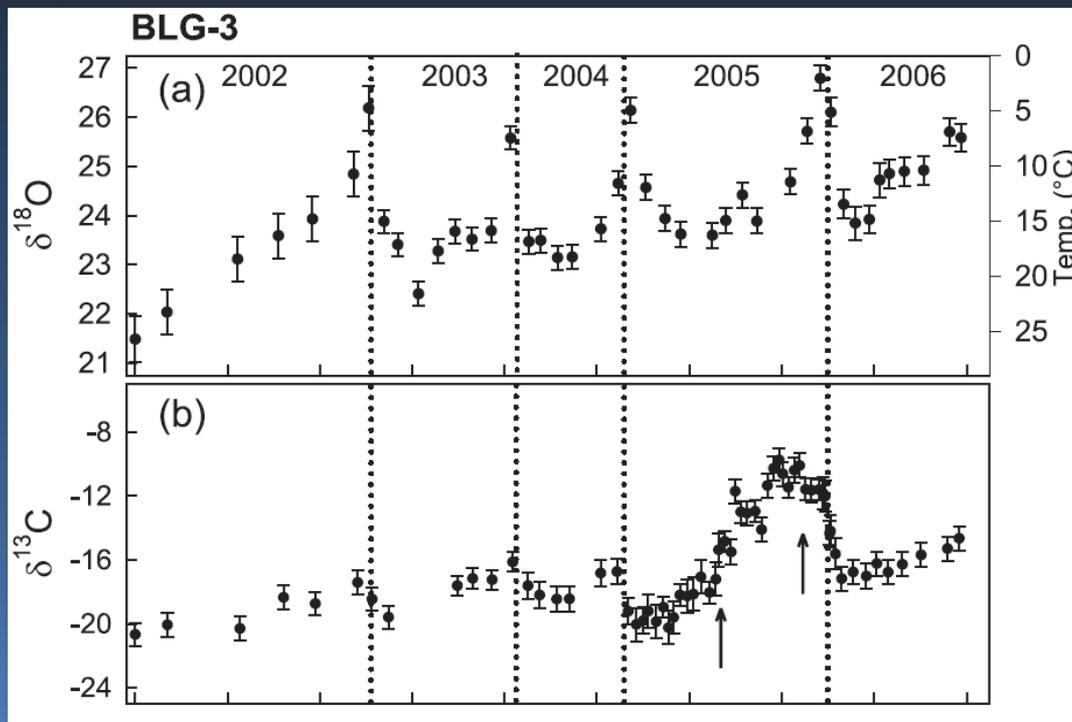
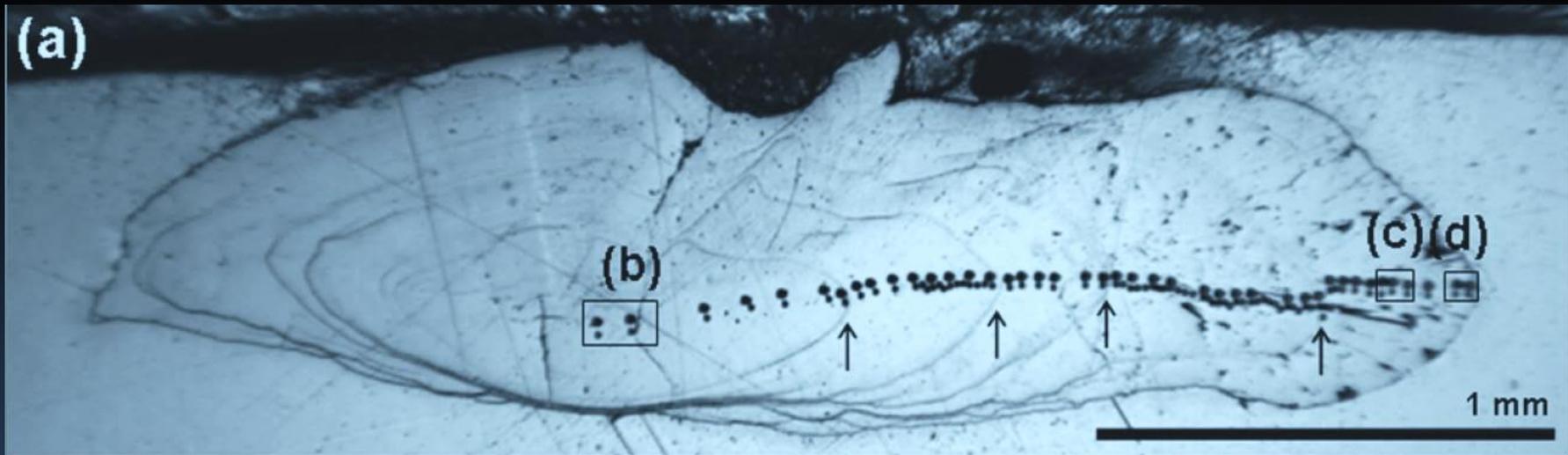
Olson et al. 2012

Otoliths



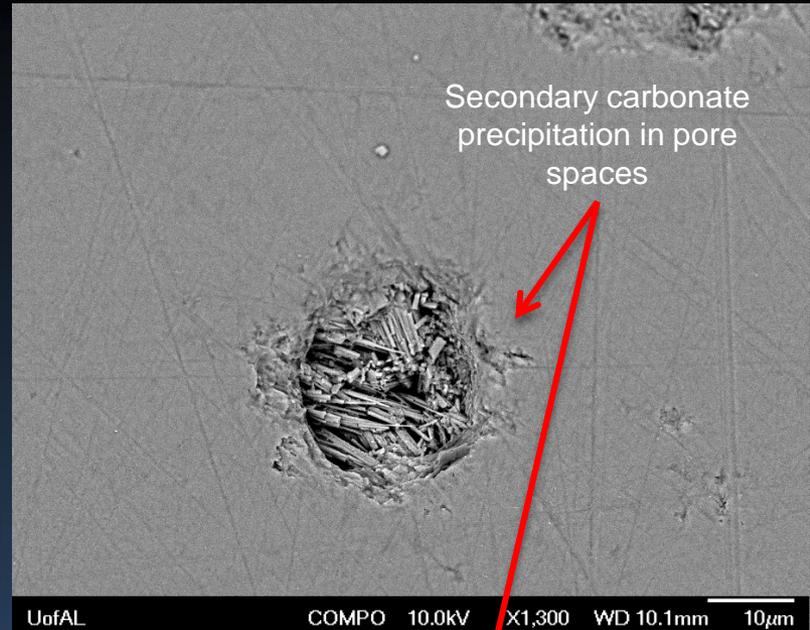
Derek Hogan, UW-Madison

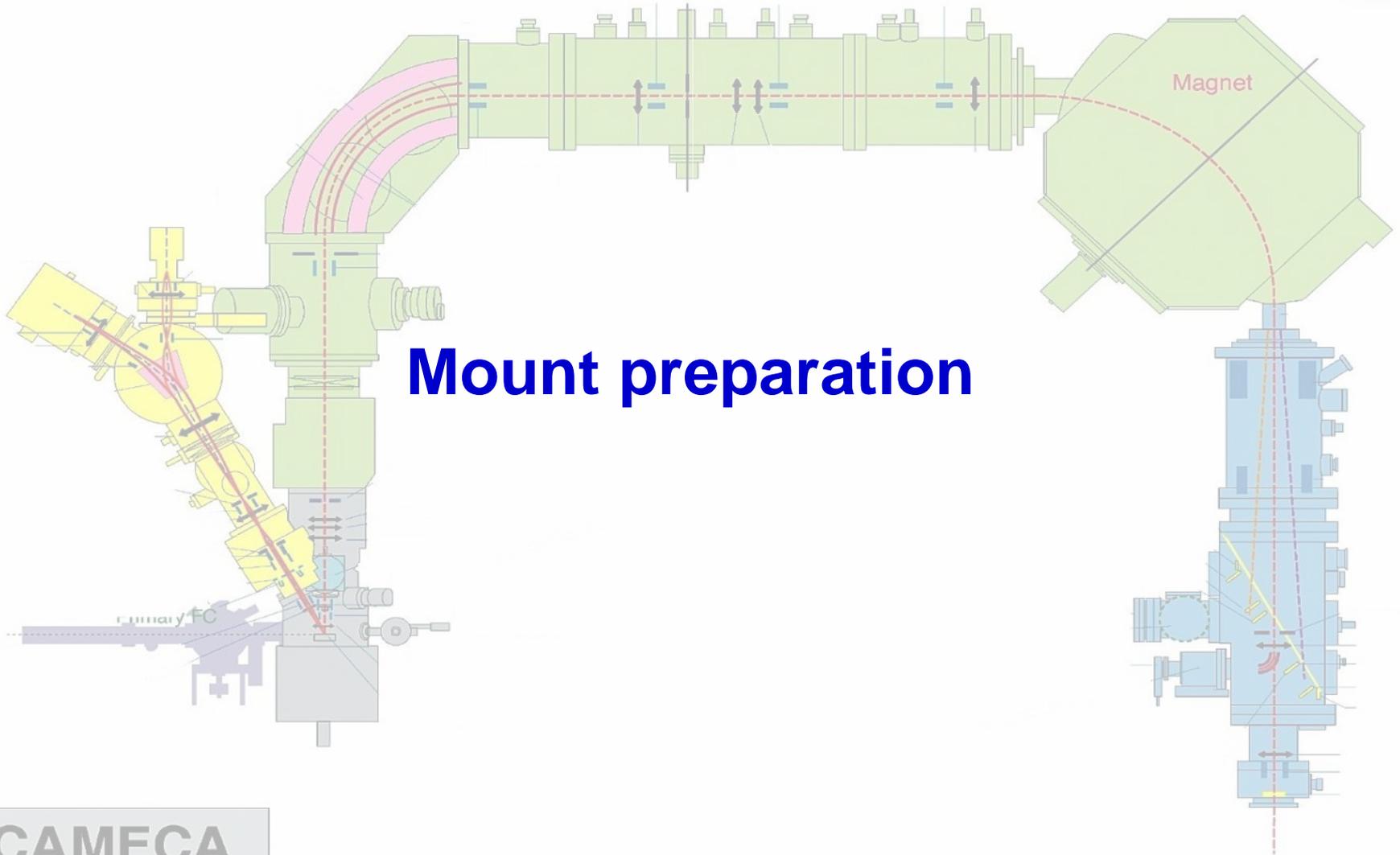
Otoliths (bluegill)



Weidel et al. 2007

Corals





Mount preparation

CAMECA

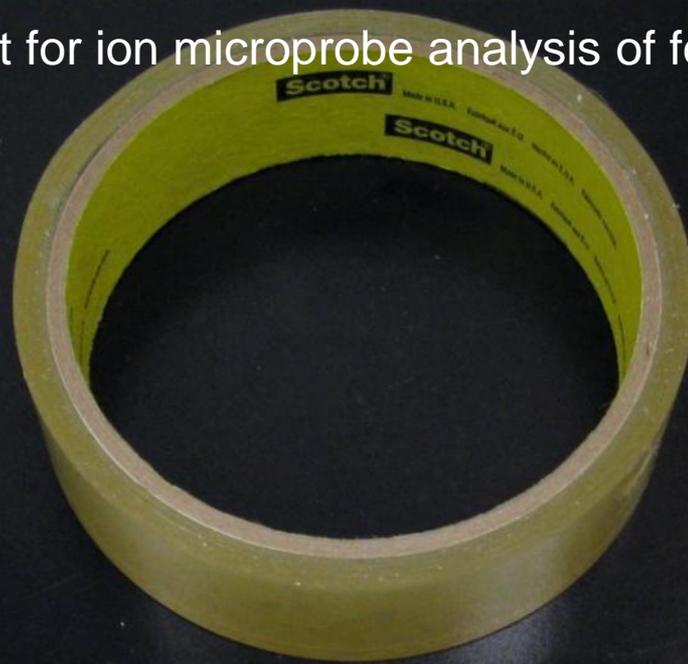
IMS 1280

Epoxy mount for ion microprobe analysis of foraminiferal shells



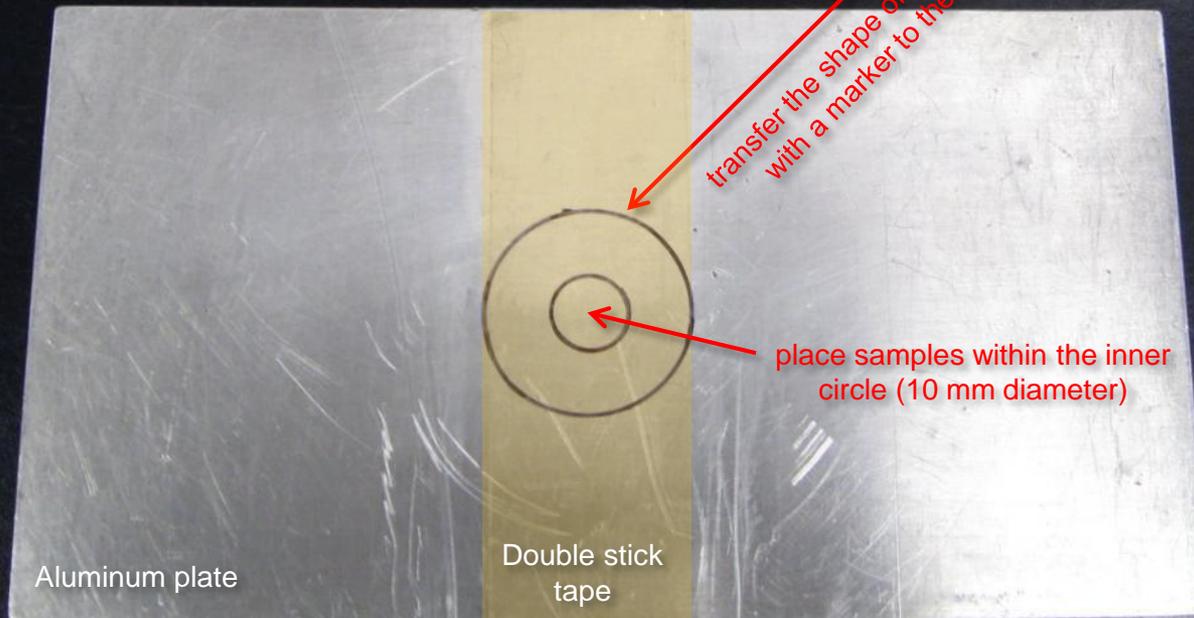
Double stick tape

- at least 1 inch width



Washer

- outer \varnothing 25.4 mm (1 inch)
- inner \varnothing 10 mm

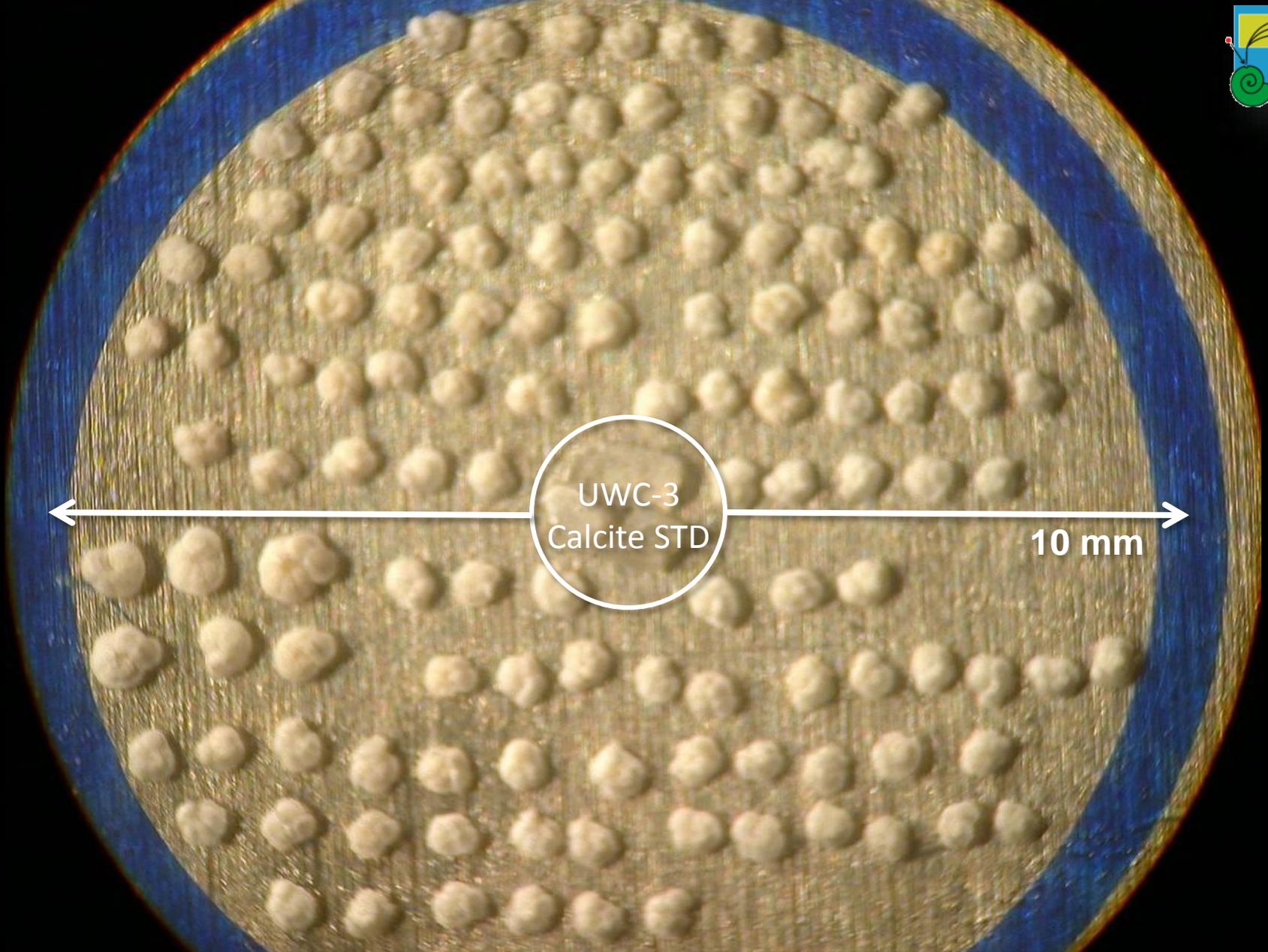


transfer the shape of the washer
with a marker to the plate

place samples within the inner
circle (10 mm diameter)

Aluminum plate

Double stick
tape



Example: Mounting of foraminiferal shells. Specimens are placed with the preferred orientation on the double stick tape (inner 10 mm of the washer marking). UWC-3 calcite standard (2 or 3 grains) are centered

Sample casting



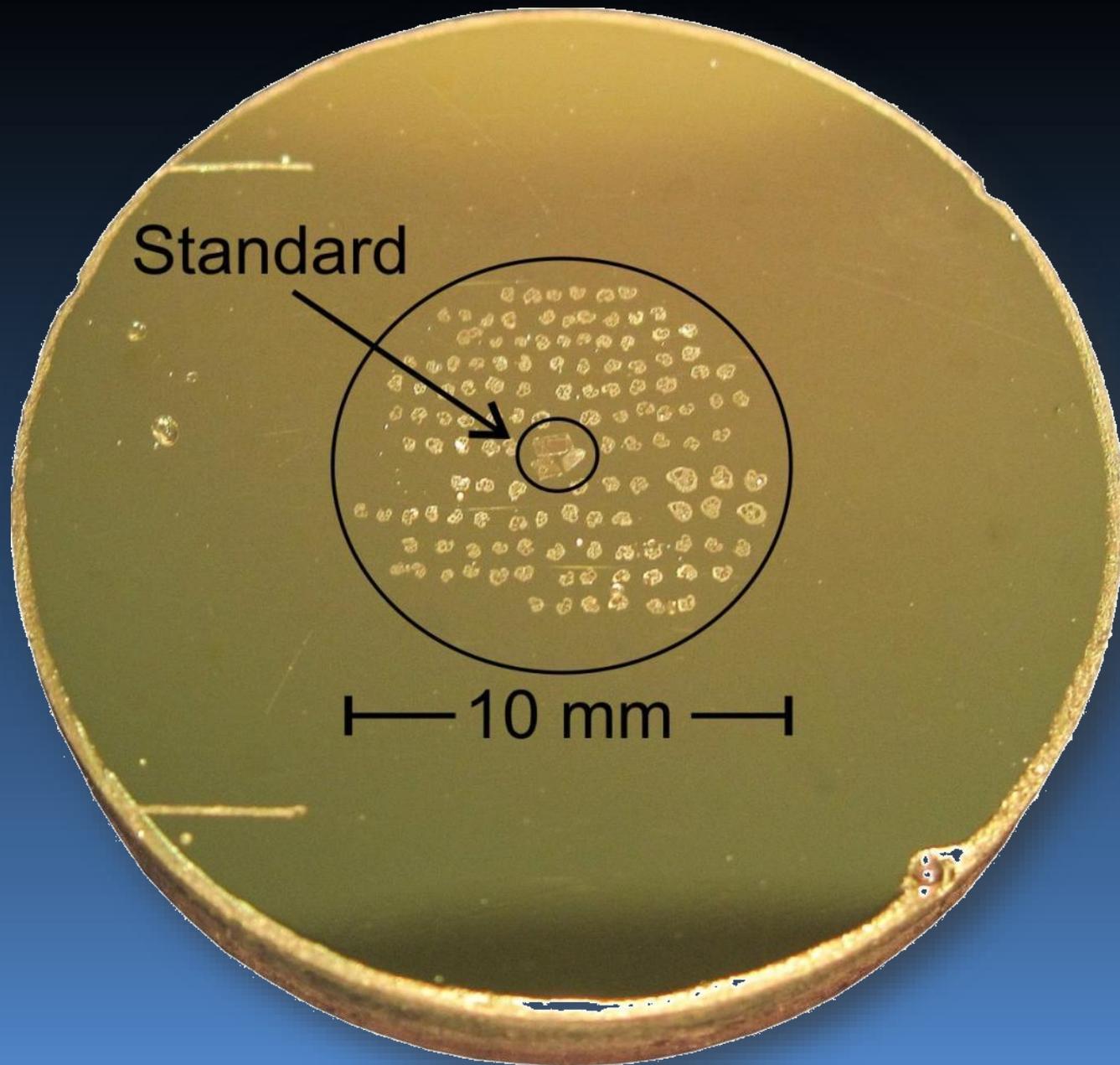
Casting
approx 6 cm³ epoxy



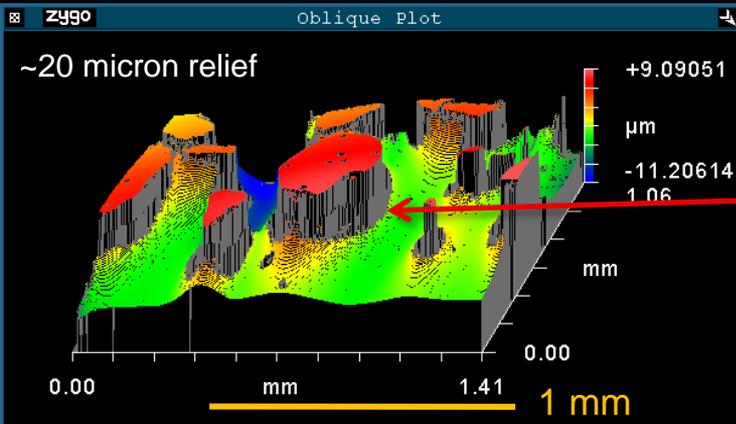
Mold (Teflon)
• inner \varnothing 25.4 mm (1 inch)

After grinding/polishing, the epoxy plug
is cut to a thickness of less than 5 mm

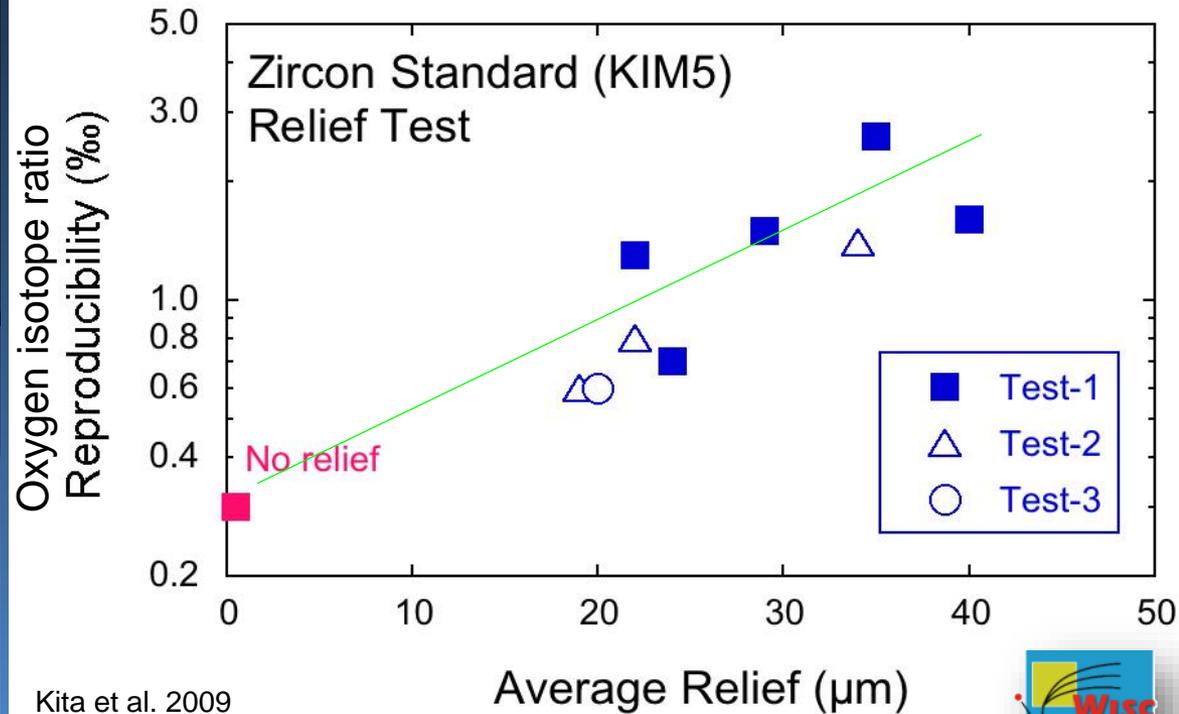
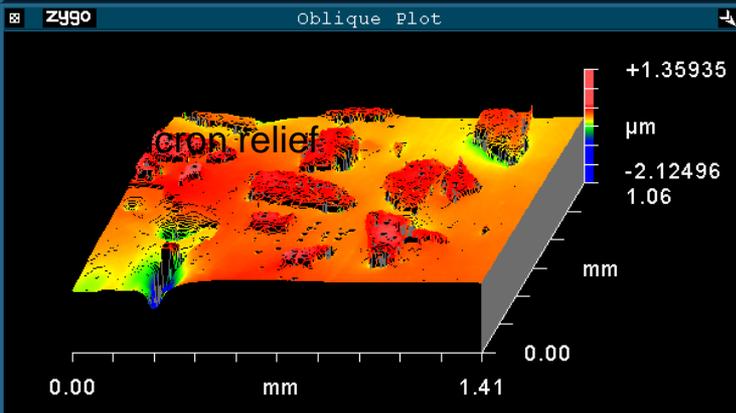
Sealant



Zircon grain mount – Evaluation of the polishing relief



KIM-5
Zircon Standard

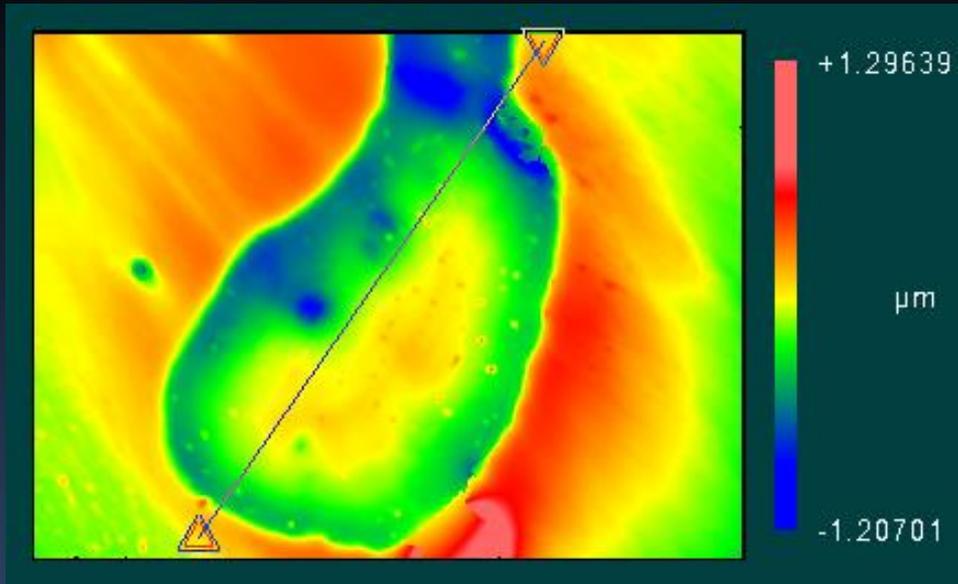


Kita et al. 2009



Example: Evaluation of the polishing relief of an otolith

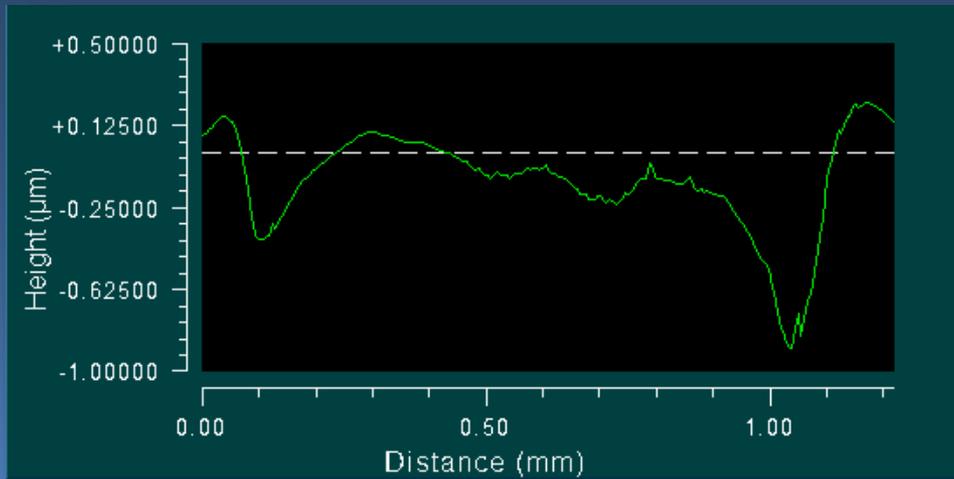
Surface Map



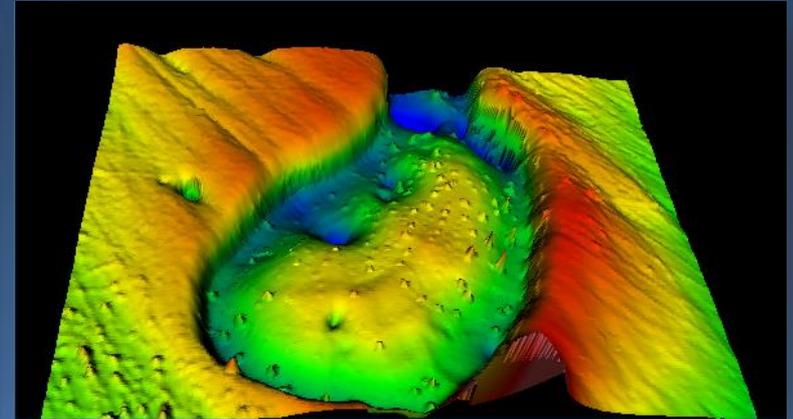
Reflected Light Image

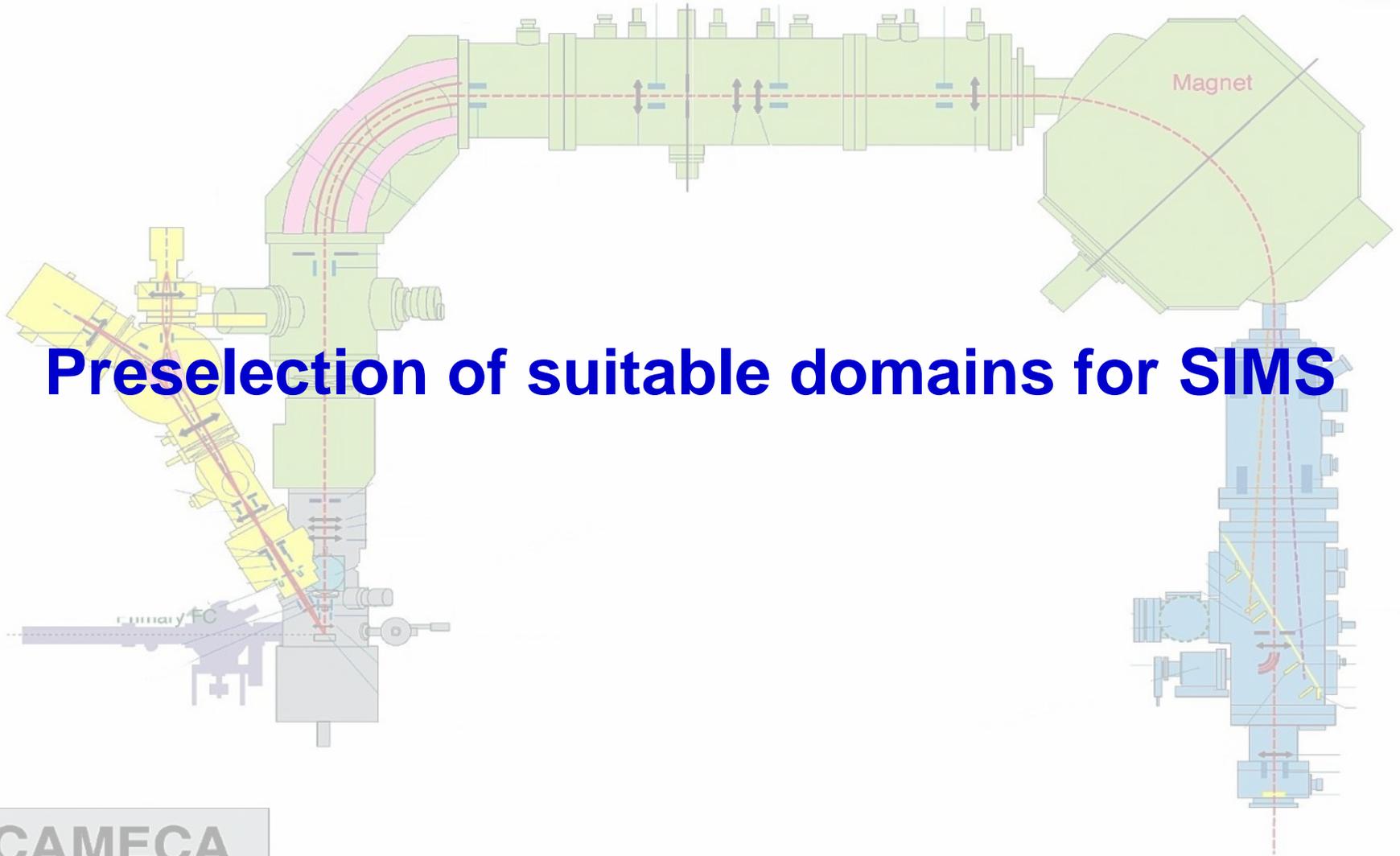


Surface Profile



3D-Model





Preselection of suitable domains for SIMS

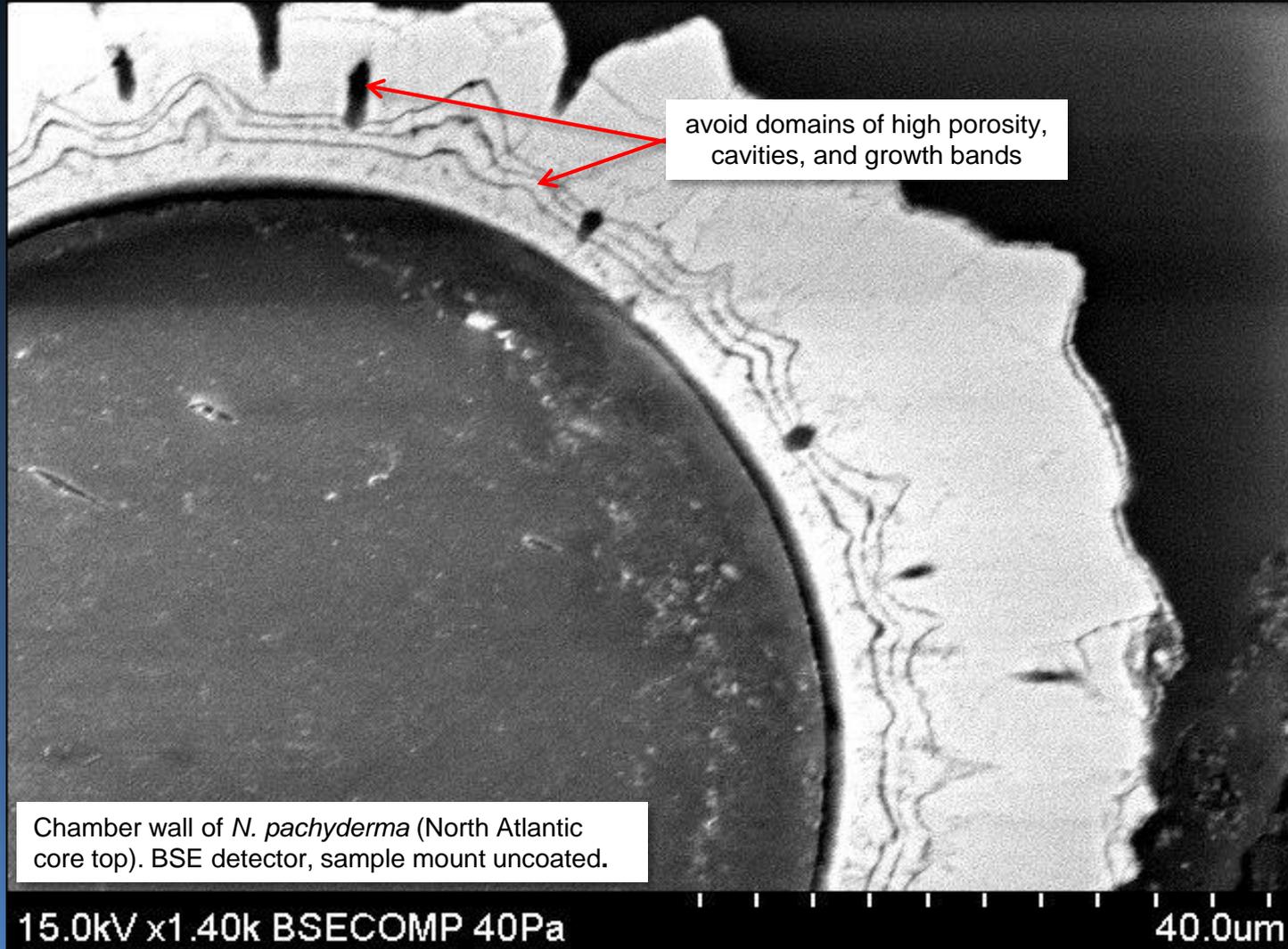
CAMECA

IMS 1280

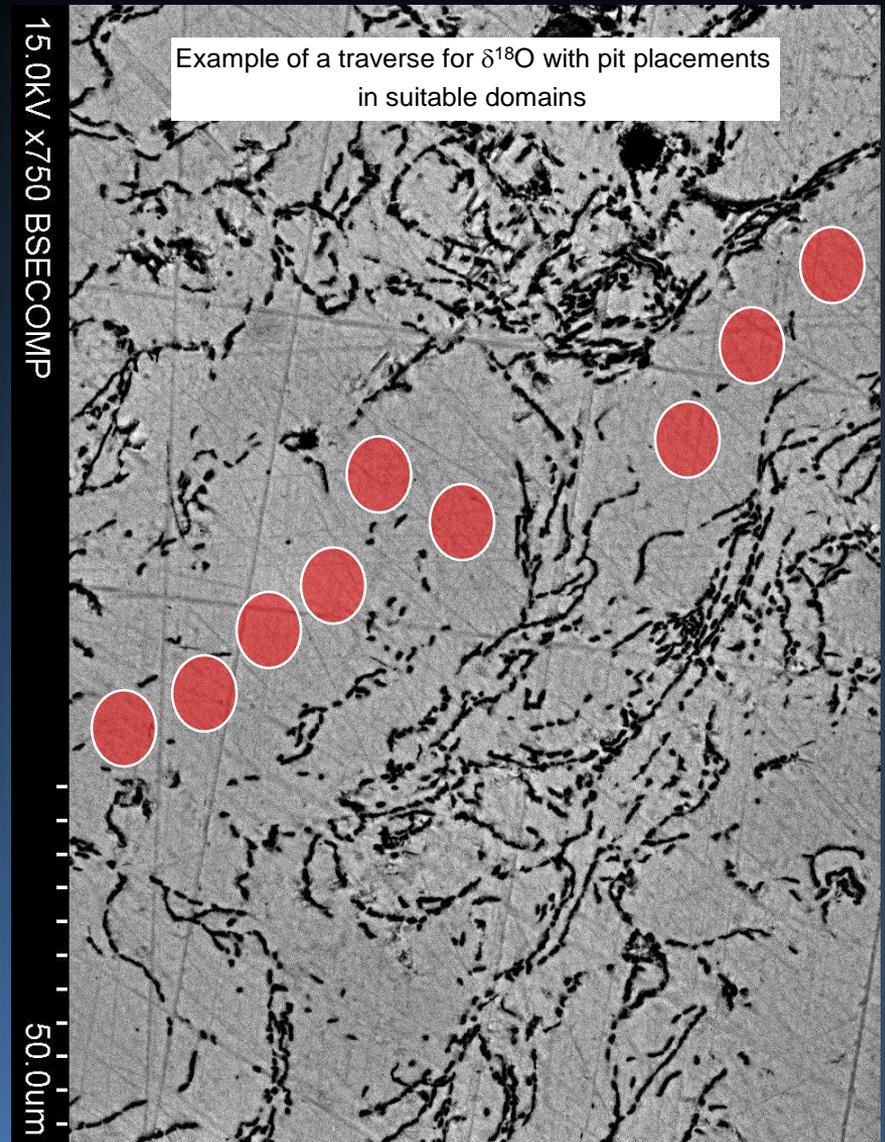
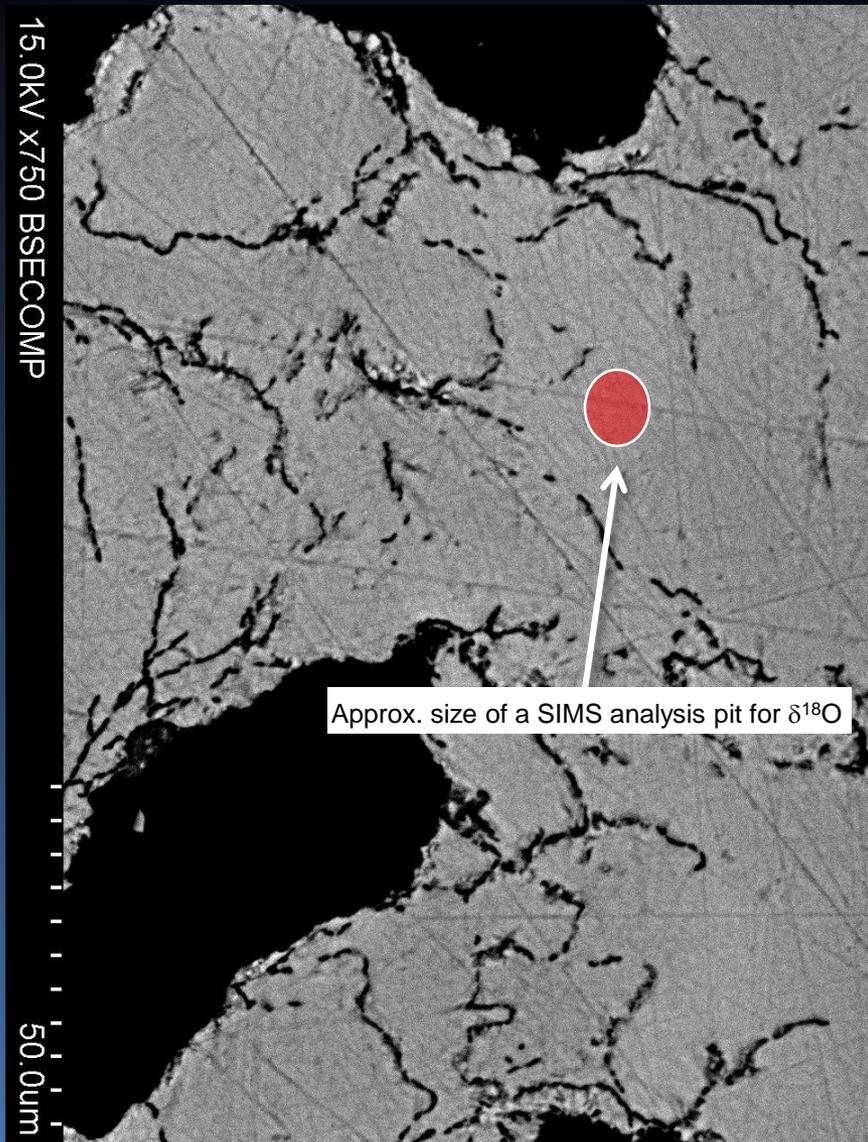
Example: Foraminiferal shells



- imaging of **uncoated** samples by SEM in environmental mode using the backscattered electron detector (BSE) has shown to be a useful approach to locate growth bands and cavities that are filled by epoxy and/or organic material
- some of these features may not be clearly visible after coating. **Only non-porous areas can be safely analyzed with high precision and accuracy.**

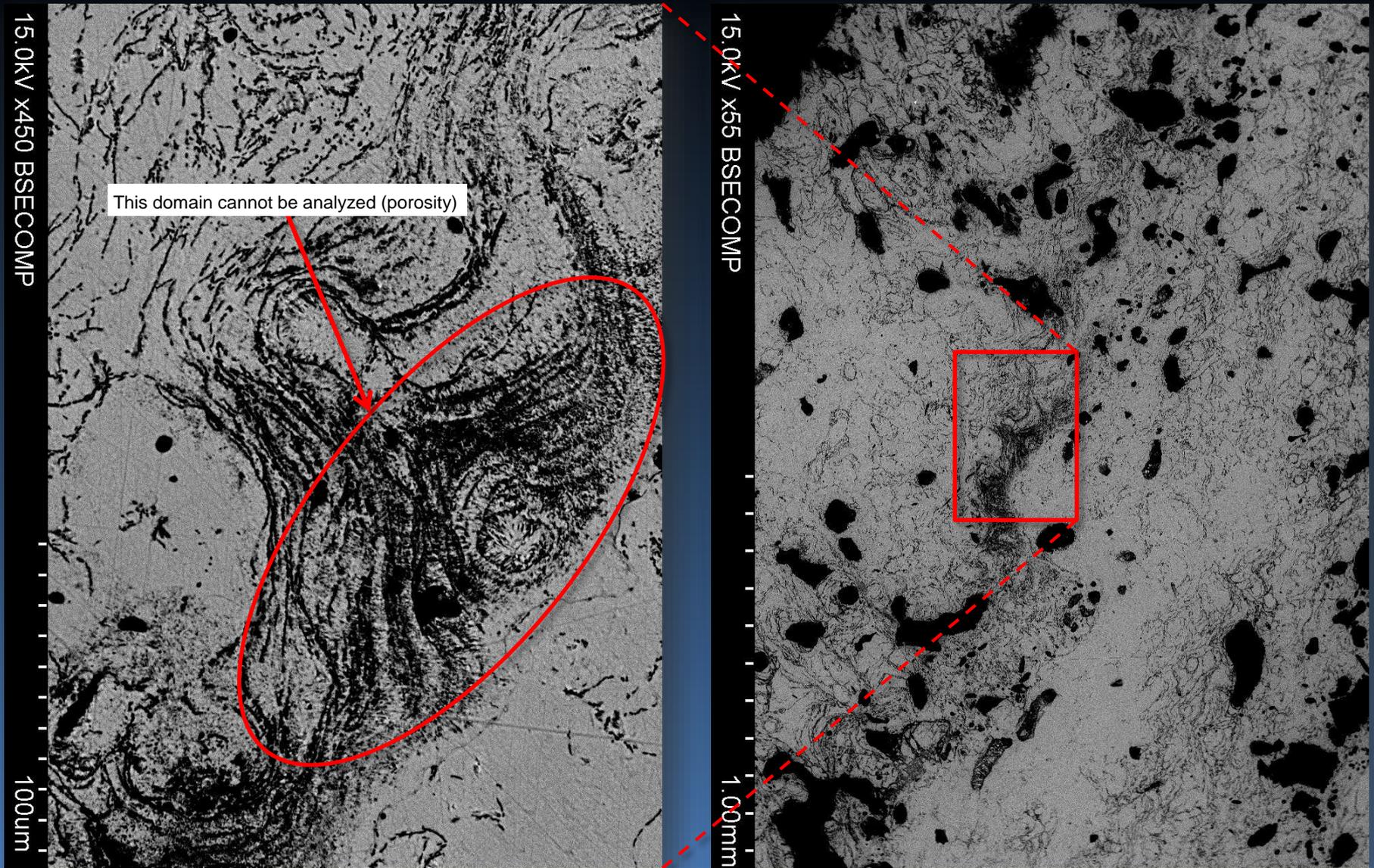


Example: Coral

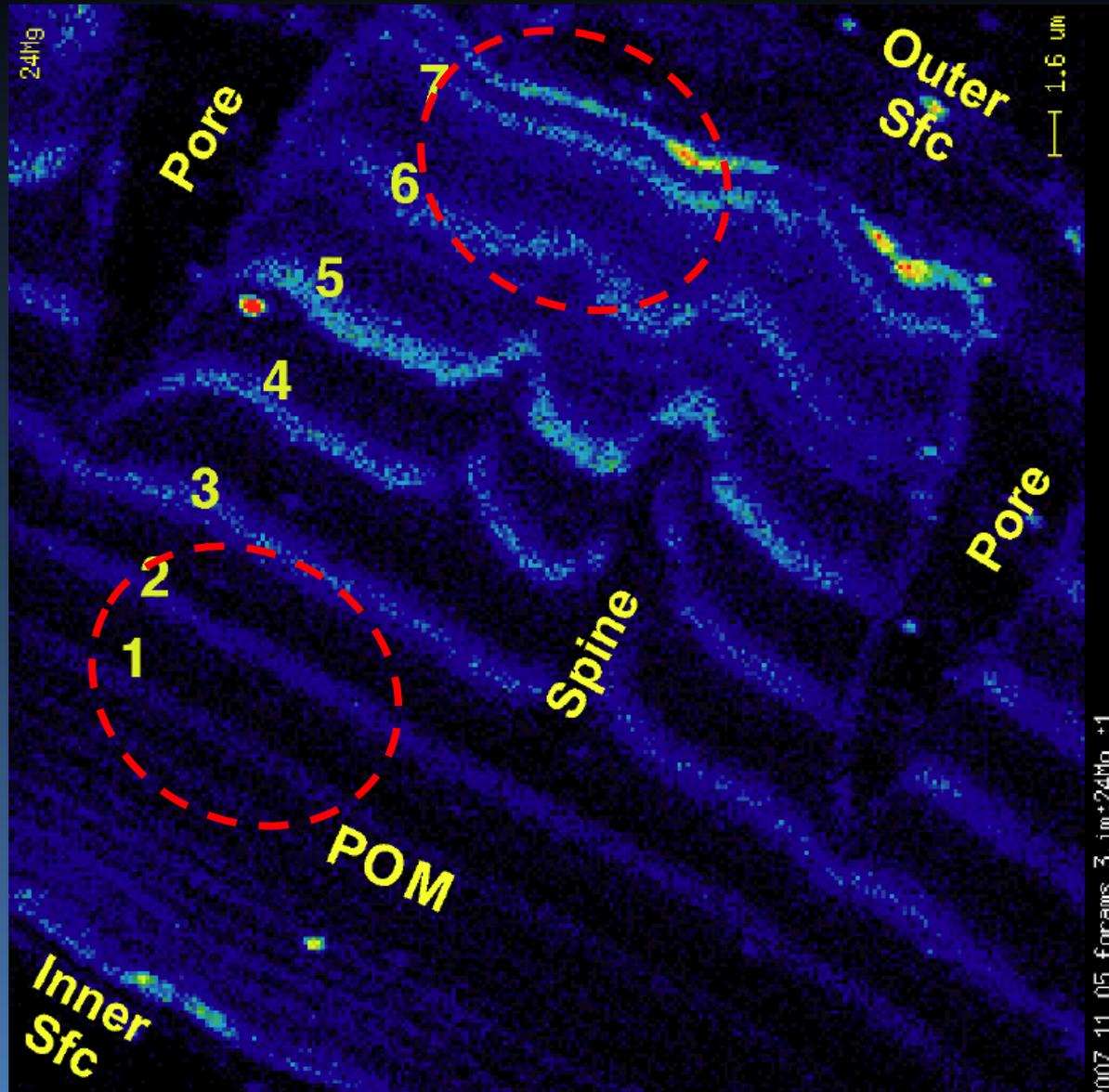


Analysis pits must be placed in nonporous domains. Data from pits overlapping epoxy or organic material may be compromised.

Example: Coral



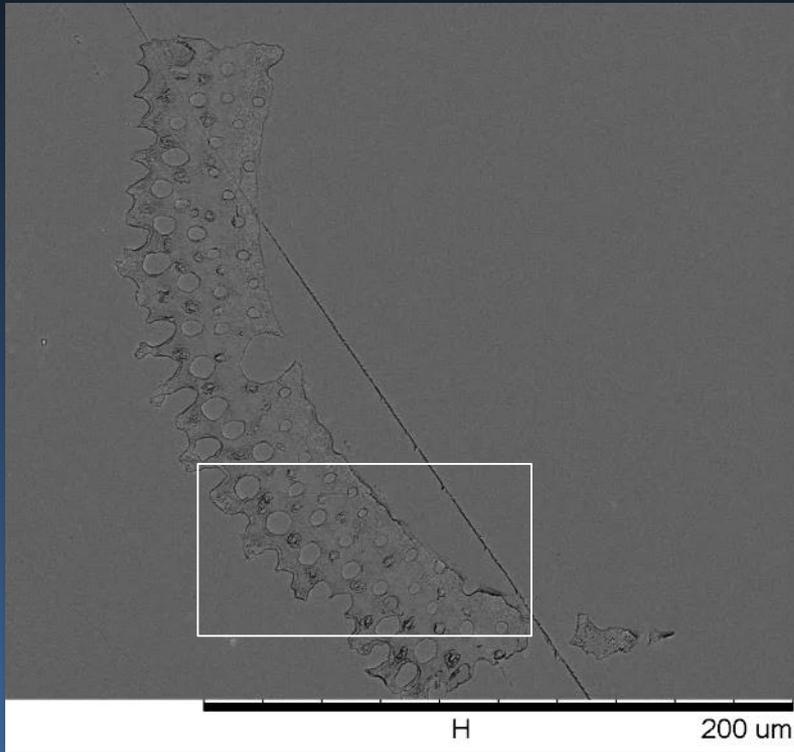
Example: Planning of $\delta^{13}\text{C}$ measurements in a foraminiferal shell.
The required spot size for $\delta^{13}\text{C}$ averages several growth bands.



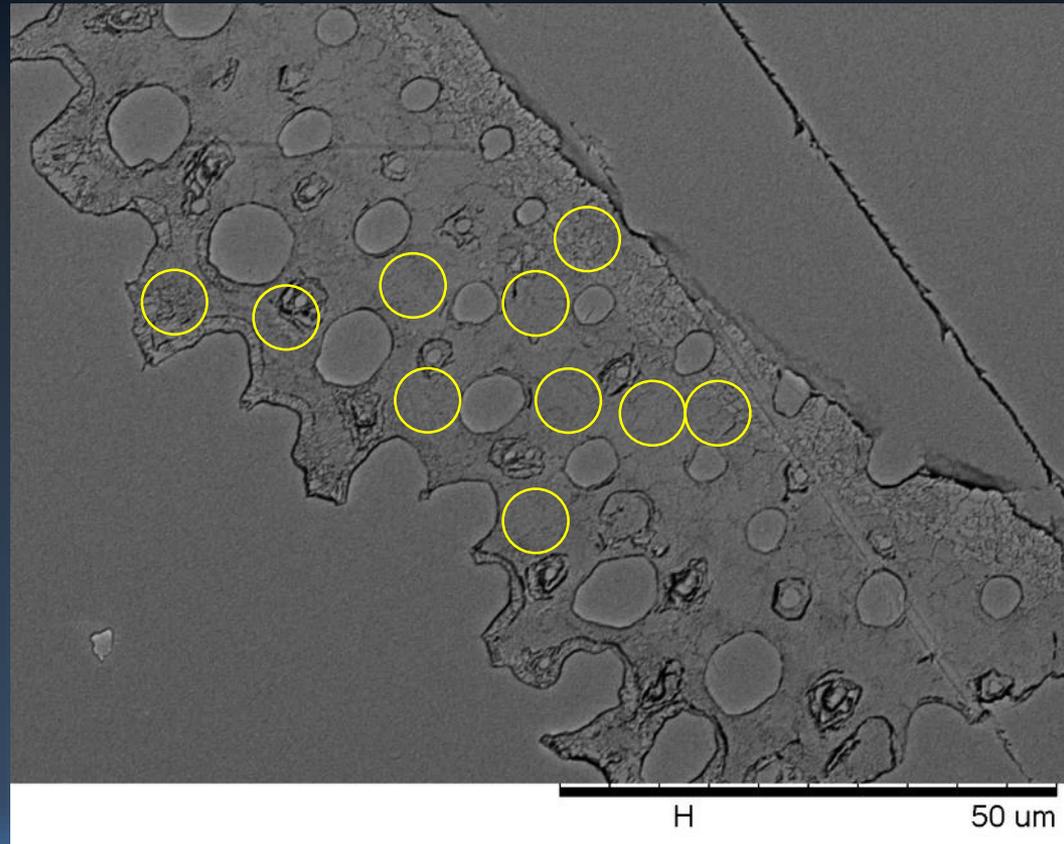
H. Spero

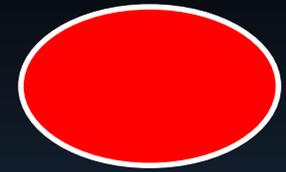
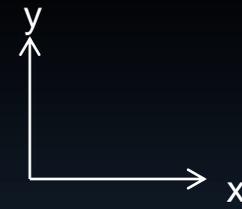
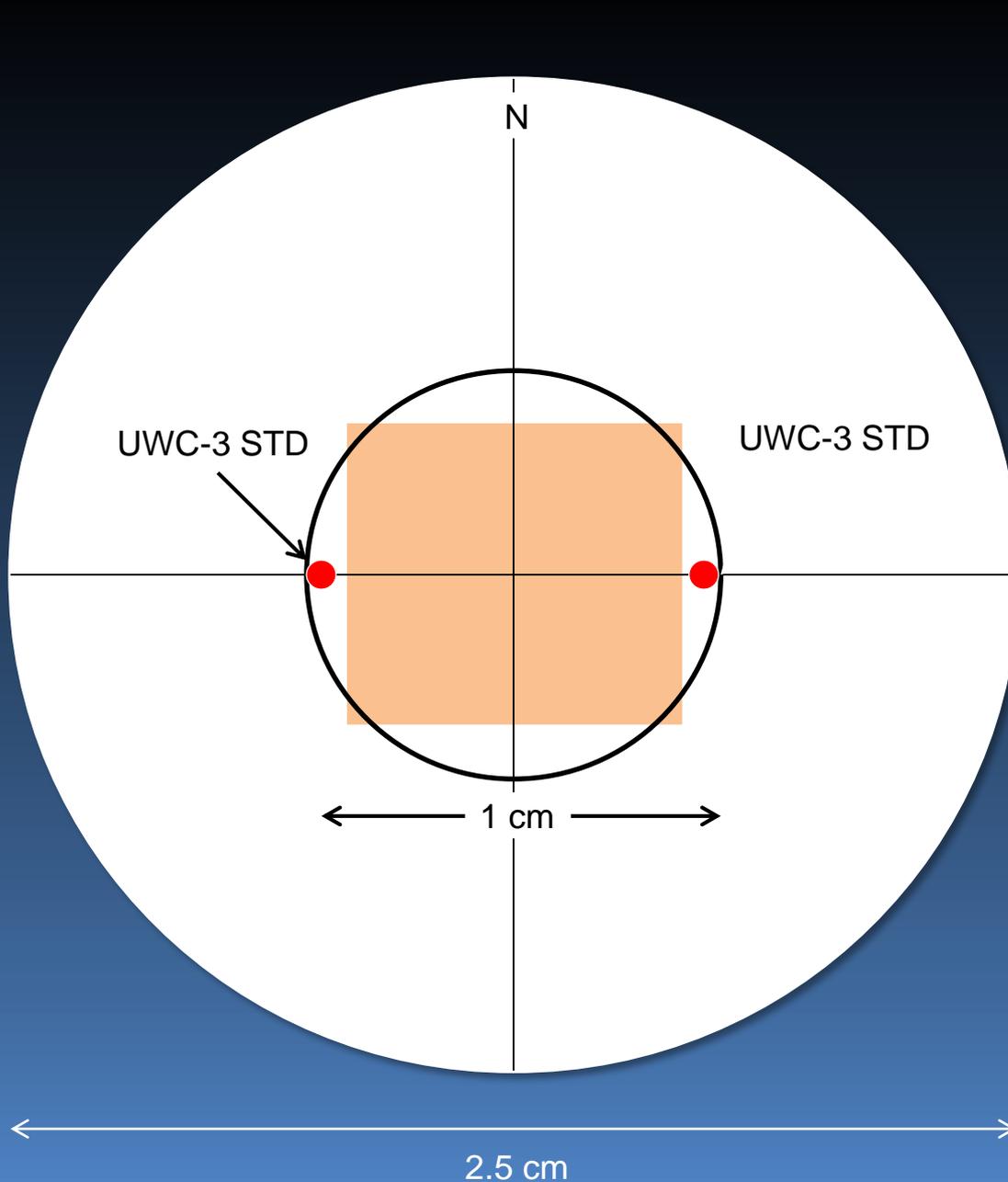
Example: Cultured Foraminifera

Planned traverses for $\delta^{13}\text{C}$ measurements



Vetter et al., in prep





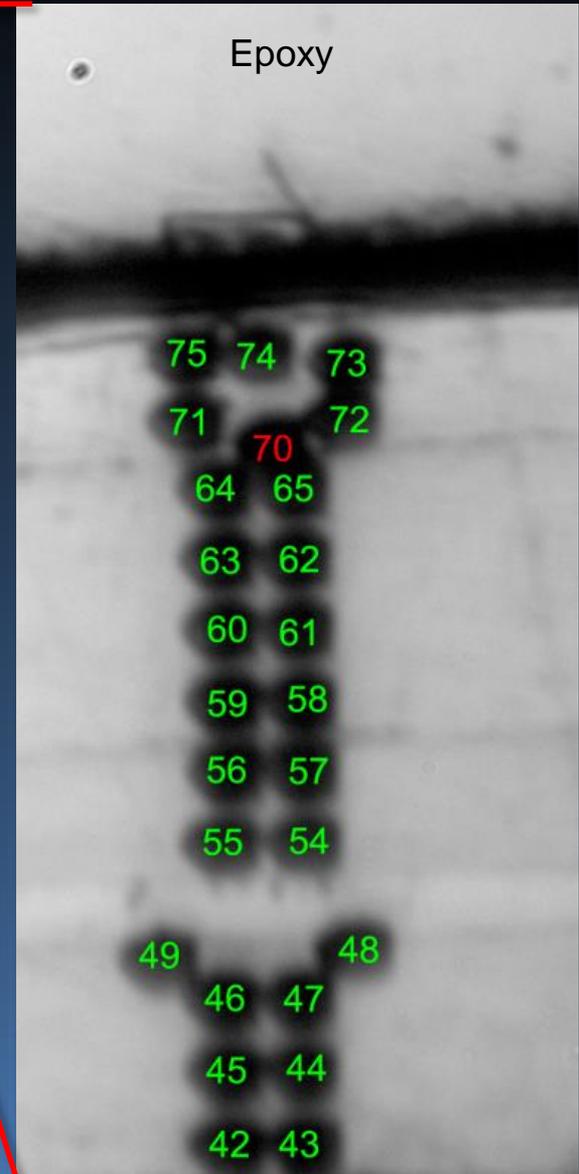
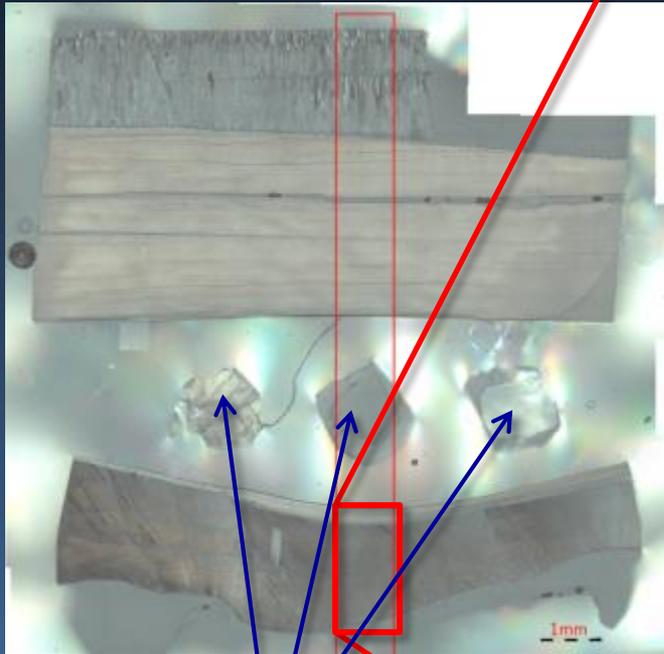
typical shape of the SIMS beam spot

The SIMS beam spot is typically slightly elongated in x-direction. Thus, traverses with high spatial resolution should be analyzed in y-direction (pits should not overlap!).

Example: Planning of $\delta^{18}\text{O}$ measurements in mollusk nacre

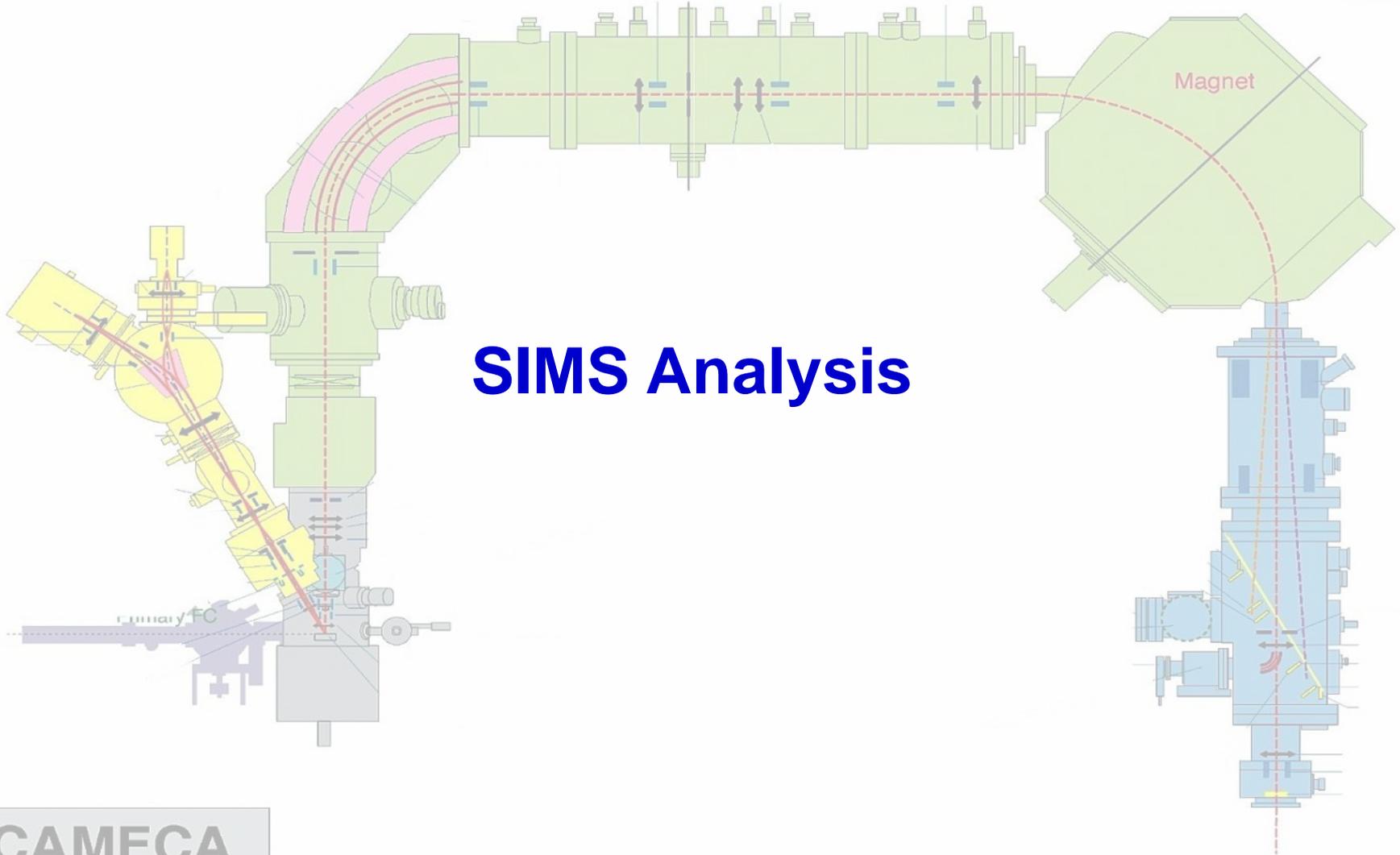
Tahitian black pearl oyster – cross section

VLM 5x, Polarized light $\theta=105^\circ$



Olson et al. 2012

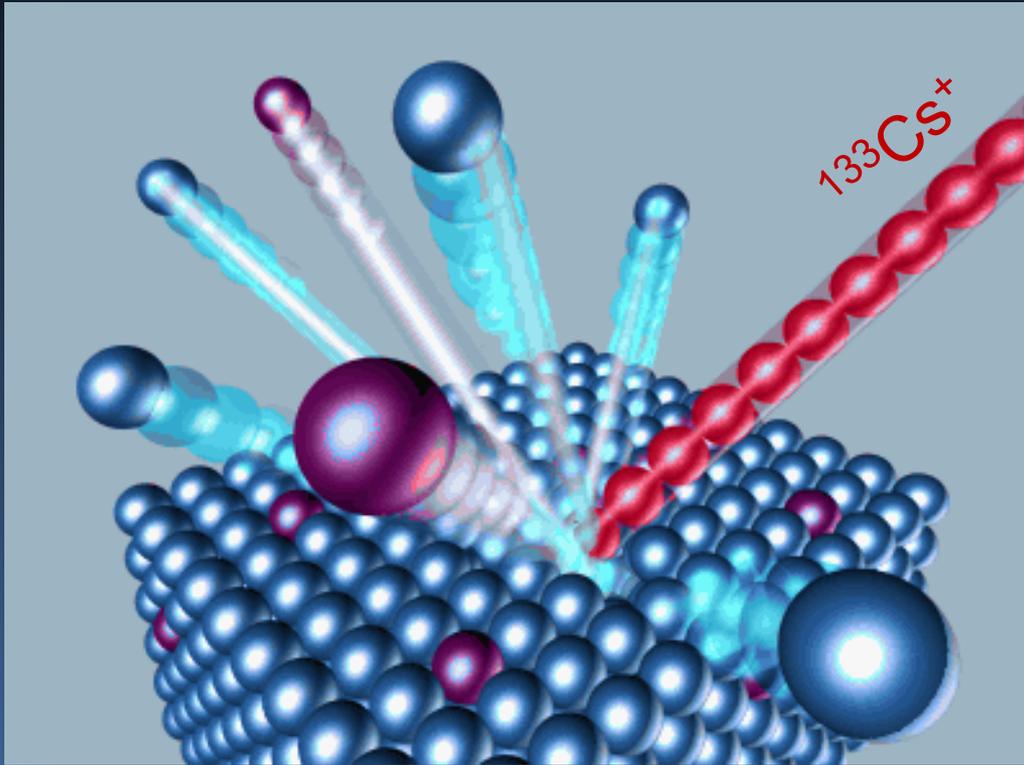
UWC-3 STD



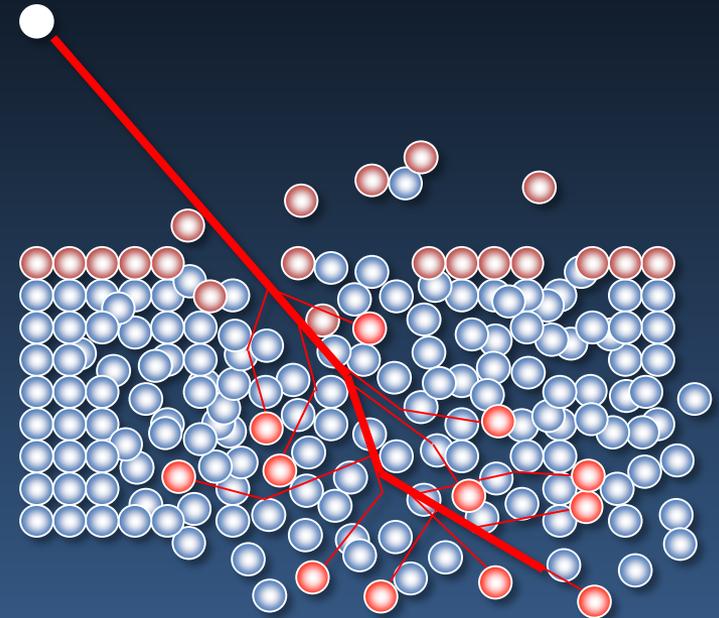
CAMECA

IMS 1280

Generation of secondary ions by sputtering



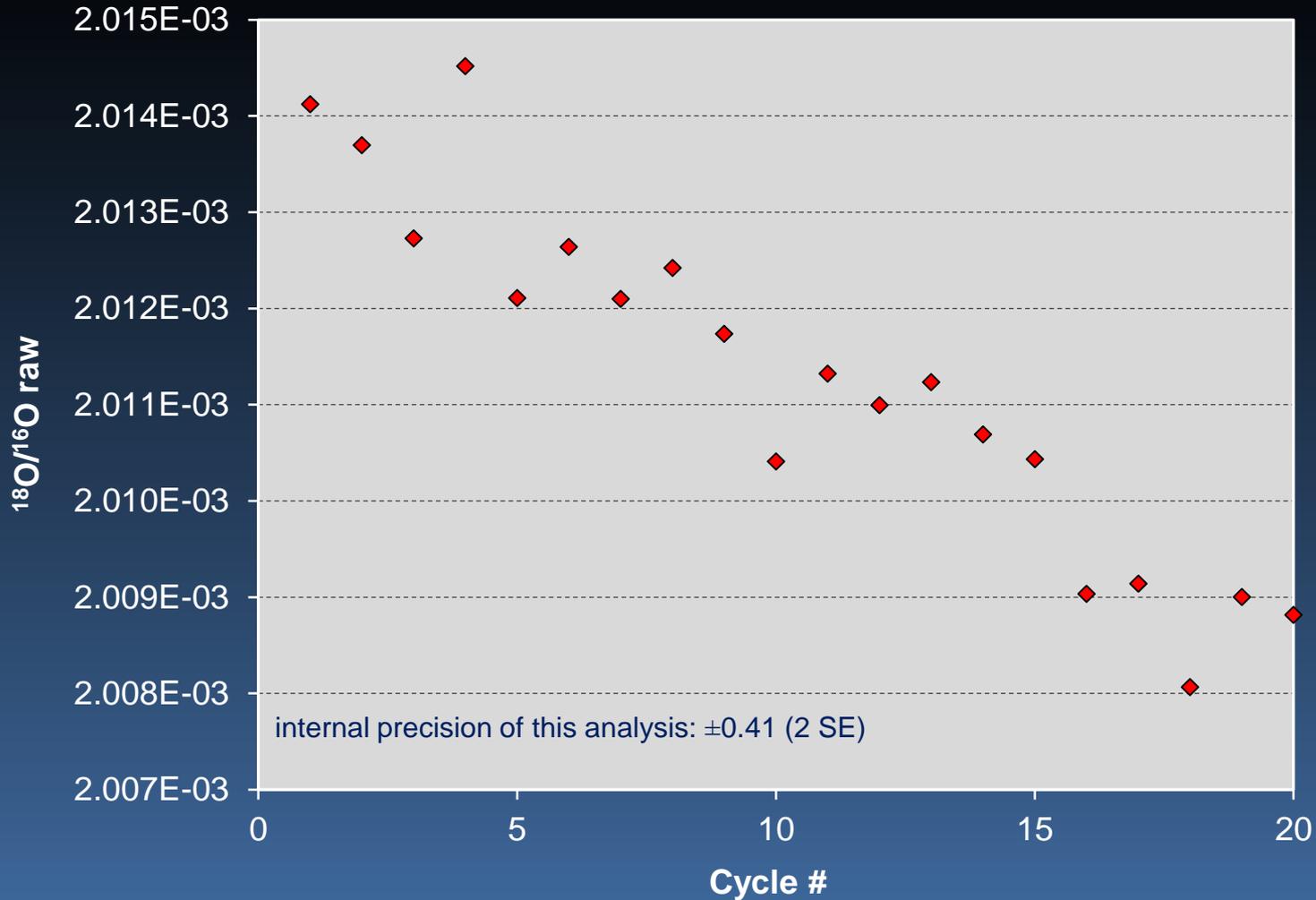
www.atomika.com



- Single atoms and clusters are ejected (collision cascade)
- A small fraction is ionized.

www.cameca.fr

UWC-3 calcite STD



The data for both ^{16}O and ^{18}O in a single spot are subdivided into a series of 20 cycles (for typical $10\ \mu\text{m}$ -spot analytical conditions), and the internal precision is based on the SE of the 20 comparisons. The $^{18}\text{O}/^{16}\text{O}$ ratio in carbonate can vary significantly with depth during a single spot analysis, leading to a high internal error. However, this depth effect is reproducible from spot to spot and it is common to obtain external precision that is significantly better than would be predicted from the internal precision.

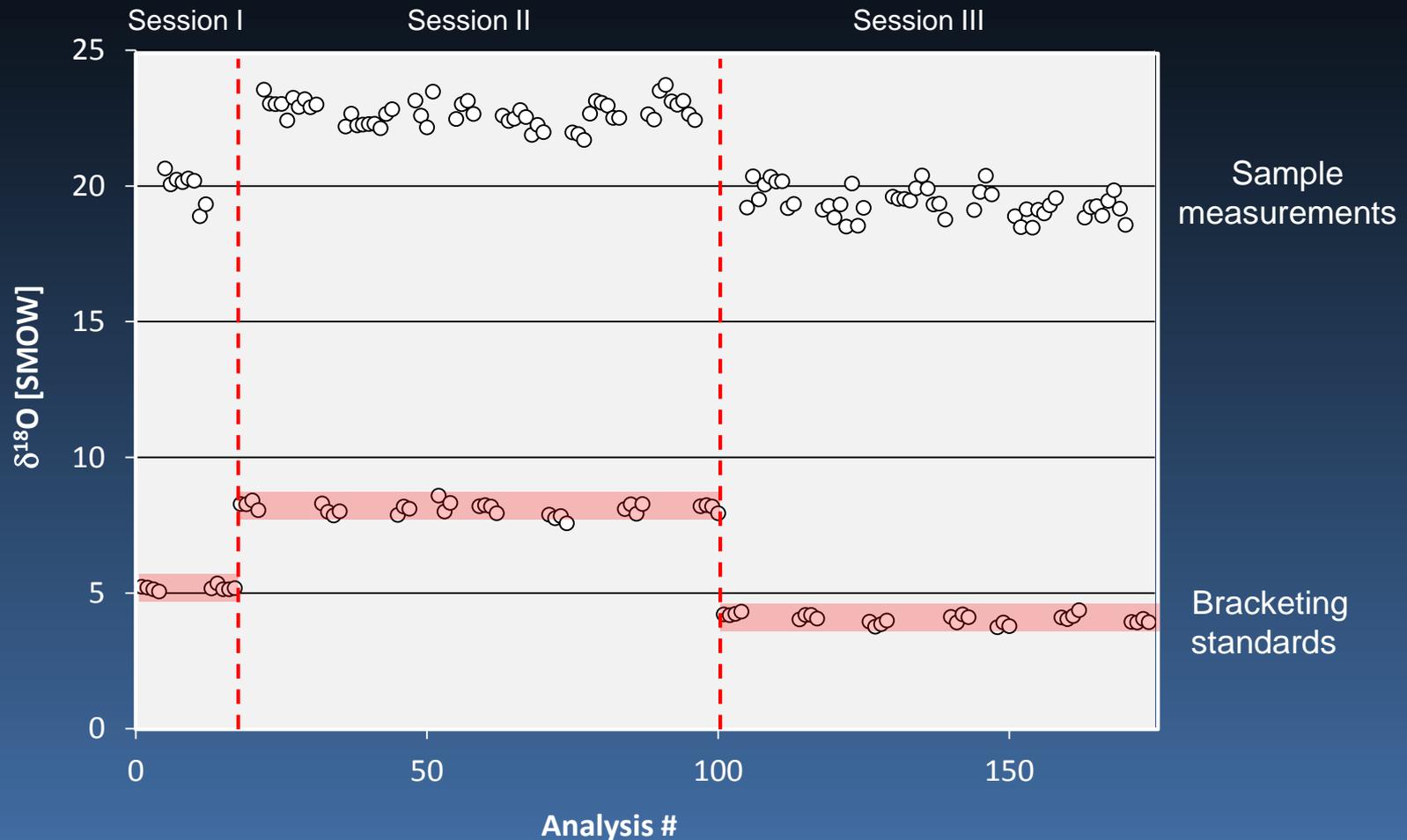
SIMS Data Table

	A	B	D	E	F	G	H	I	J	K	L
	File	Comment	d18O[SMOW]	IMF	d18O_m	d18O-2SE	16O(E9 cps)	IP(nA)	Yield (E9cps/nA)	Yield (% of bracketing STD)	date
5	20130125@68.asc	UWC-3			2.711	0.534	1.962	0.668	2.939		1/25/20
6	20130125@69.asc	UWC-3, Cs = 154			2.841	0.374	2.053	0.703	2.921		1/25/20
7	20130125@70.asc	UWC-3			2.902	0.475	2.084	0.730	2.855		1/25/20
8	20130125@71.asc	UWC-3, Cs = 155			2.765	0.606	2.174	0.771	2.821		1/25/20
9		bracket: average and 2 SD		0.99054	2.909	0.282			2.858		
10			d18O[SMOW]	±2SD							
12	20130125@72.asc	Shell 20 penult gam 72	28.13	0.24	18.388	0.540	2.135	0.811	2.632	92	1/25/20
13	20130125@73.asc	Shell 20 ult gam 73 (low yield)			17.510	0.631	2.009	0.810	2.479	87	1/25/20
14	20130125@74.asc	Shell 21 penult gam 74	28.18	0.24	18.429	0.569	2.078	0.809	2.568	90	1/25/20
15	20130125@75.asc	Shell 21 ult 75	27.90	0.24	18.160	0.445	2.038	0.794	2.566	90	1/25/20
16	20130125@76.asc	Shell 21 penult 76 (low yield)			14.828	0.828	1.801	0.795	2.265	79	1/25/20
17	20130125@77.asc	Shell 22 S 77	27.13	0.24	17.393	0.509	2.043	0.798	2.561	90	1/25/20
18	20130125@78.asc	Shell 22 S gam 78	27.84	0.24	18.094	0.468	2.126	0.798	2.665	93	1/25/20
19	20130125@79.asc	Shell 23 E gam 79	28.26	0.24	18.511	0.444	2.120	0.791	2.682	94	1/25/20
20	20130125@80.asc	Shell 23 NW 80	28.42	0.24	18.675	0.539	2.030	0.785	2.587	90	1/25/20
21	20130125@81.asc	Shell 24 N 81	28.75	0.24	18.998	0.501	2.083	0.770	2.705	95	1/25/20
22	20130125@82.asc	Shell 25 N 82	28.73	0.24	18.975	0.465	2.061	0.763	2.703	94	1/25/20
23	20130125@83.asc	Shell 25 N 83	28.12	0.24	18.370	0.403	1.953	0.753	2.593	91	1/25/20
24	20130125@84.asc	Shell 26 S 84 (low yield)			16.323	0.725	1.857	0.750	2.477	87	1/25/20
25	20130125@85.asc	Shell 26 S 85	29.00	0.24	19.243	0.585	2.027	0.742	2.733	96	1/25/20
26	20130125@86.asc	Shell 27 W 86 (low yield)			14.351	1.583	1.586	0.732	2.167	76	1/25/20
27											
28	20130125@87.asc	UWC-3			3.013	0.508	2.078	0.728	2.854		1/25/20
29	20130125@88.asc	UWC-3			2.882	0.507	2.071	0.720	2.878		1/25/20
30	20130125@89.asc	UWC-3, Cs-res. = 156			3.045	0.479	2.127	0.750	2.835		1/25/20
31	20130125@90.asc	UWC-3			2.976	0.415	2.149	0.773	2.780		1/25/20
32		bracket: average and 2 SD		0.99052	2.892	0.235			2.860		

average $\delta^{18}\text{O}$ [measured] of the eight bracketing STD analyses

± 2SD of the bracketing STD

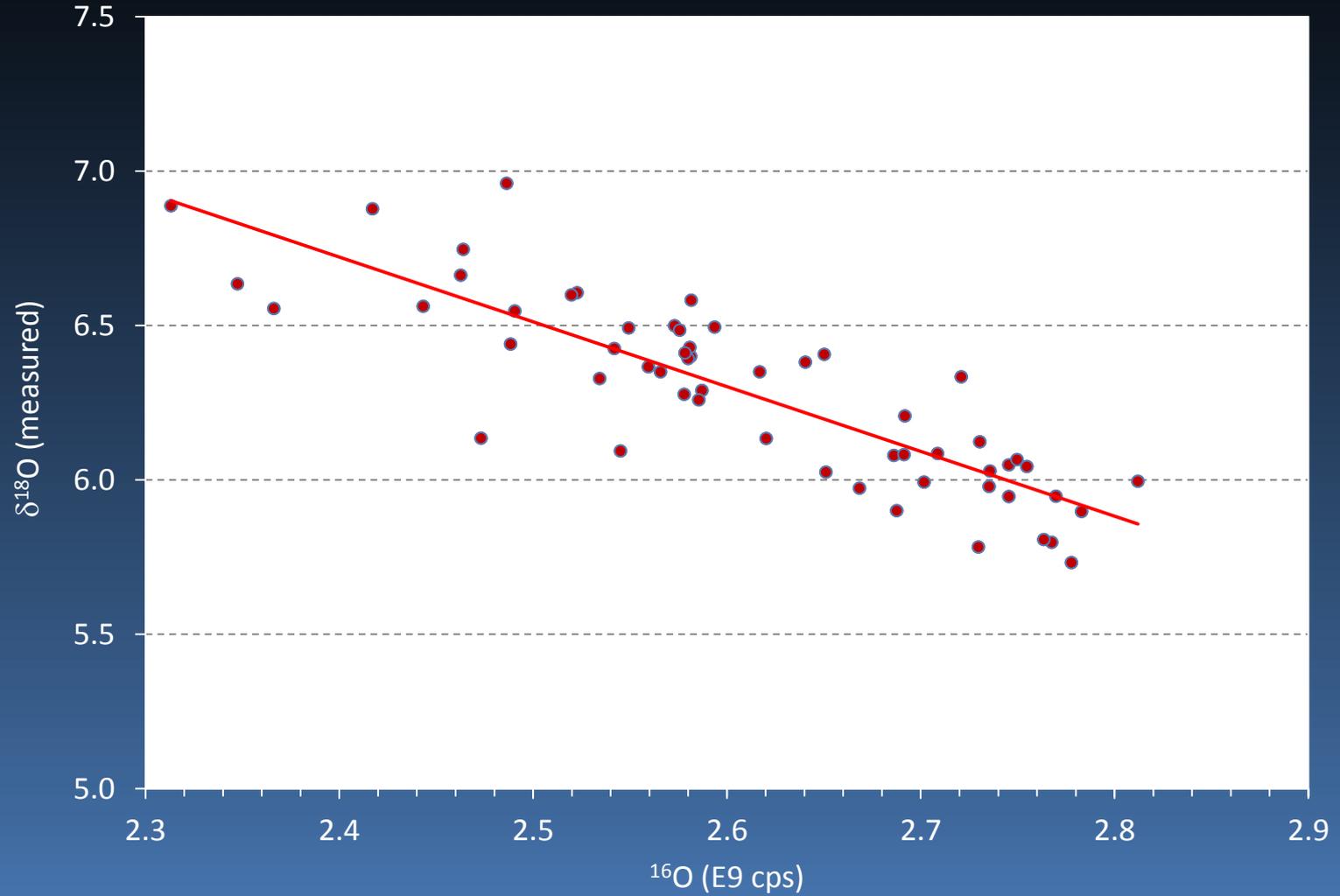
Spot-to-spot precision of $\pm 0.3\text{‰}$ (2SD) in $\delta^{18}\text{O}$ with 10 μm beam-spot

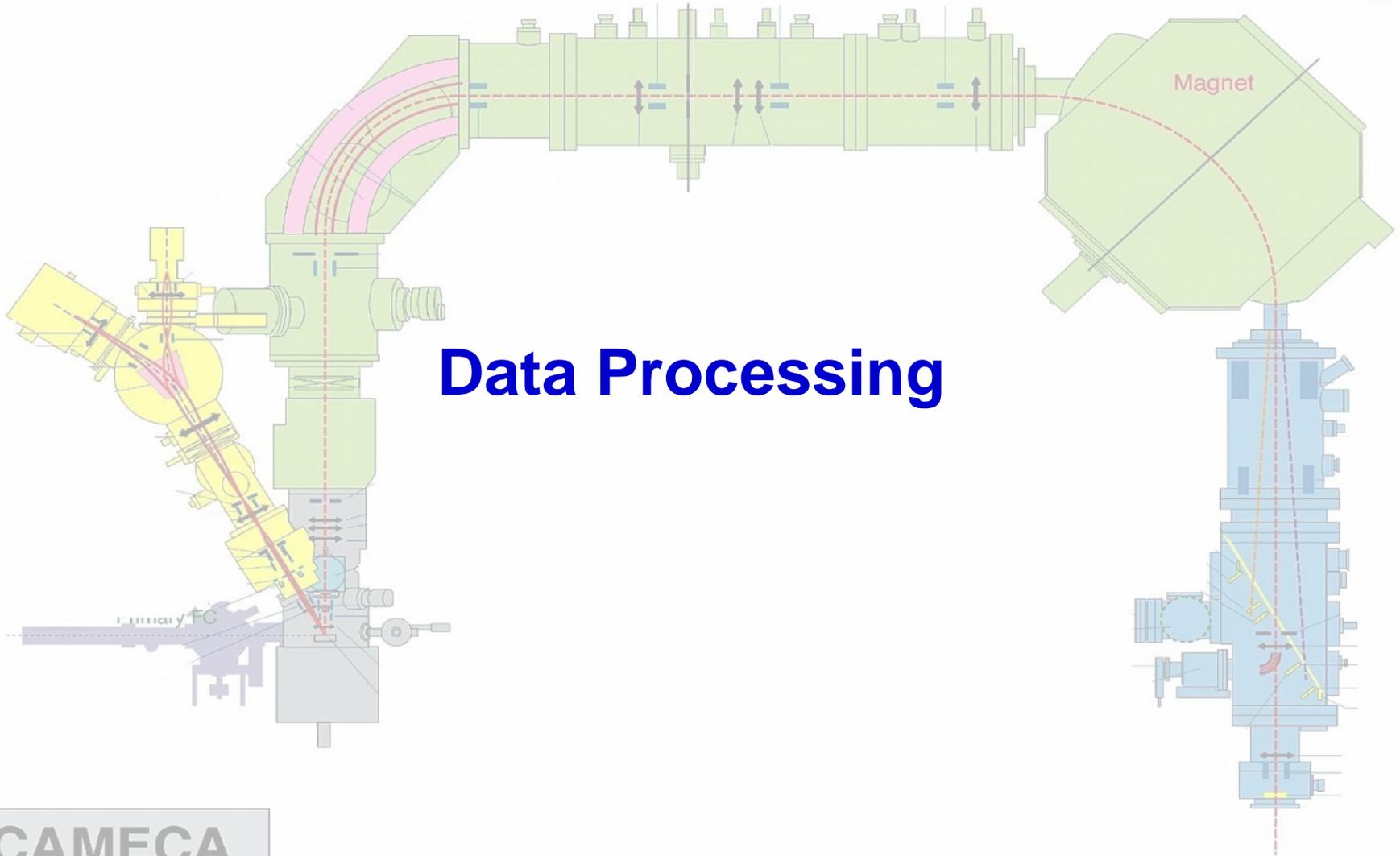


$^{16}\text{O}^-$ [cps] = $\sim 2 \times 10^9$

$^{18}\text{O}^-$ [cps] = $\sim 4 \times 10^6$ (FC-amplifier background: 1000 cps)

A consistent primary beam intensity is essential for carbonate analyses





CAMECA

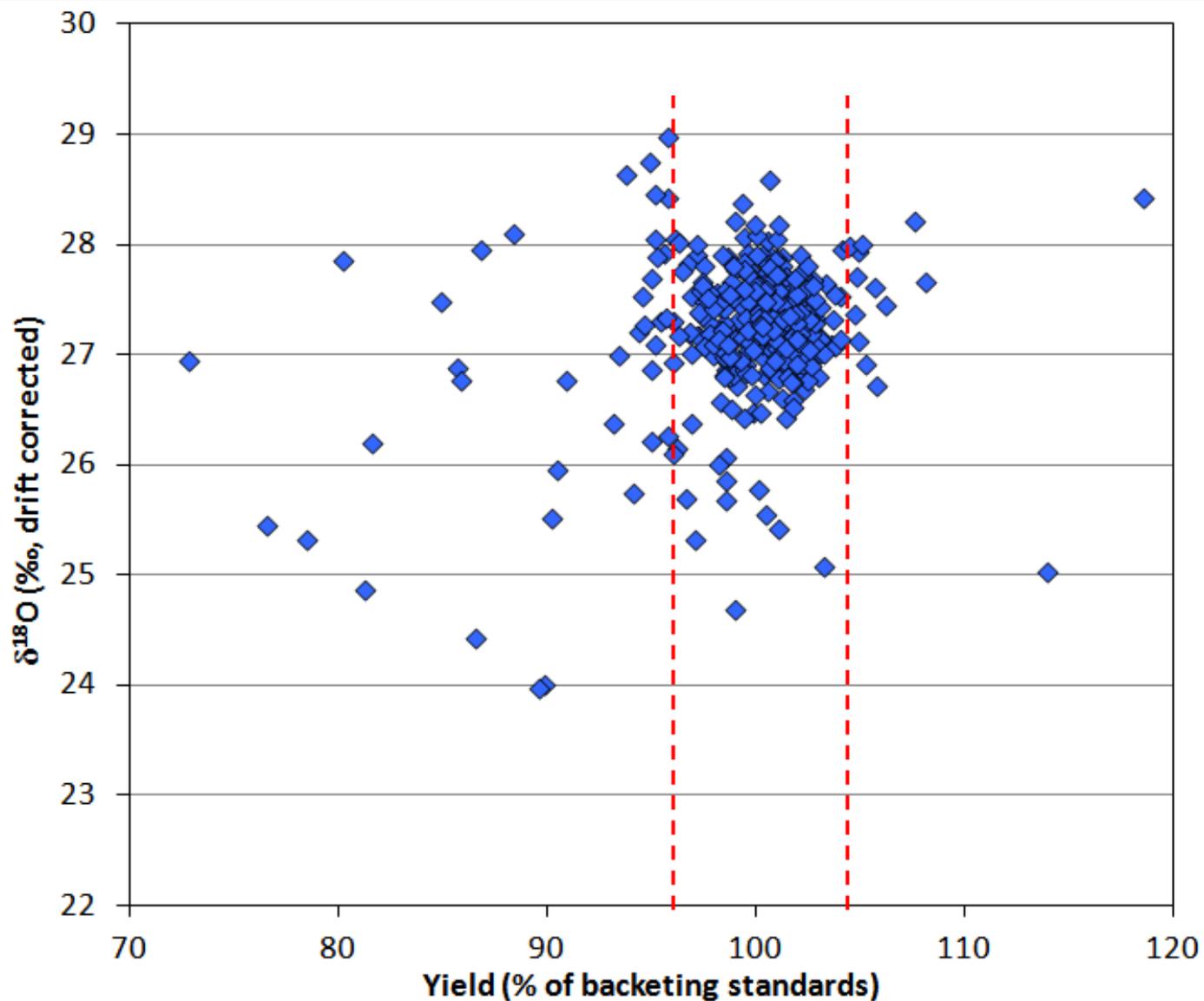
IMS 1280

SIMS Data Table

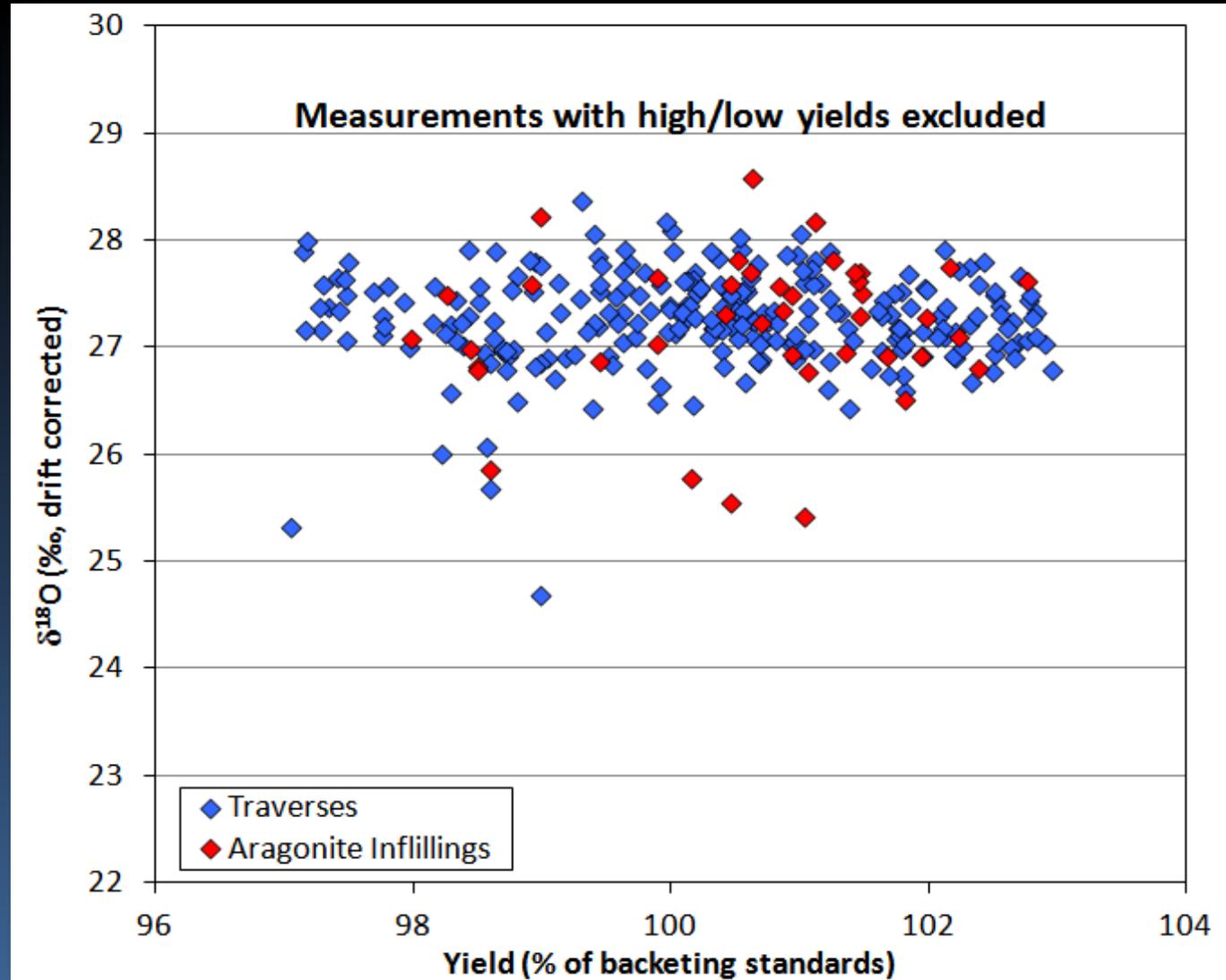
	A	B	D	E	F	G	H	I	J	K	L
	File	Comment	d18O[SMOW]	IMF	d18O_m	d18O-2SE	16O(E9 cps)	IP(nA)	Yield (E9cps/nA)	Yield (% of bracketing STD)	date
5	20130125@68.asc	UWC-3			2.711	0.534	1.962	0.668	2.939		1/25/20
6	20130125@69.asc	UWC-3, Cs = 154			2.841	0.374	2.053	0.703	2.921		1/25/20
7	20130125@70.asc	UWC-3			2.902	0.475	2.084	0.730	2.855		1/25/20
8	20130125@71.asc	UWC-3, Cs = 155			2.765	0.606	2.174	0.771	2.821		1/25/20
9		bracket: average and 2 SD		0.99054	2.909	0.282			2.858		
10											
11			d18O[SMOW]	±2SD							
12	20130125@72.asc	Shell 20 penult gam 72	28.13	0.24	18.388	0.540	2.135	0.811	2.632	92	1/25/20
13	20130125@73.asc	Shell 20 ult gam 73 (low yield)			17.510	0.631	2.009	0.810	2.479	87	1/25/20
14	20130125@74.asc	Shell 21 penult gam 74	28.18	0.24	18.429	0.569	2.078	0.809	2.568	90	1/25/20
15	20130125@75.asc	Shell 21 ult 75	27.90	0.24	18.160	0.445	2.038	0.794	2.566	90	1/25/20
16	20130125@76.asc	Shell 21 penult 76 (low yield)			14.828	0.828	1.801	0.795	2.265	79	1/25/20
17	20130125@77.asc	Shell 22 S 77	27.13	0.24	17.393	0.509	2.043	0.798	2.561	90	1/25/20
18	20130125@78.asc	Shell 22 S gam 78	27.84	0.24	18.094	0.468	2.126	0.798	2.665	93	1/25/20
19	20130125@79.asc	Shell 23 E gam 79	28.26	0.24	18.511	0.444	2.120	0.791	2.682	94	1/25/20
20	20130125@80.asc	Shell 23 NW 80	28.42	0.24	18.675	0.539	2.030	0.785	2.587	90	1/25/20
21	20130125@81.asc	Shell 24 N 81	28.75	0.24	18.998	0.501	2.083	0.770	2.705	95	1/25/20
22	20130125@82.asc	Shell 25 N 82	28.73	0.24	18.975	0.465	2.061	0.763	2.703	94	1/25/20
23	20130125@83.asc	Shell 25 N 83	28.12	0.24	18.370	0.403	1.953	0.753	2.593	91	1/25/20
24	20130125@84.asc	Shell 26 S 84 (low yield)			16.323	0.725	1.857	0.750	2.477	87	1/25/20
25	20130125@85.asc	Shell 26 S 85	29.00	0.24	19.243	0.585	2.027	0.742	2.733	96	1/25/20
26	20130125@86.asc	Shell 27 W 86 (low yield)			14.351	1.583	1.586	0.732	2.167	76	1/25/20
27											
28	20130125@87.asc	UWC-3			3.013	0.508	2.078	0.728	2.854		1/25/20
29	20130125@88.asc	UWC-3			2.882	0.507	2.071	0.720	2.878		1/25/20
30	20130125@89.asc	UWC-3, Cs-res. = 156			3.045	0.479	2.127	0.750	2.835		1/25/20
31	20130125@90.asc	UWC-3			2.976	0.415	2.149	0.773	2.780		1/25/20
32		bracket: average and 2 SD		0.99052	2.892	0.235			2.860		
33											

high internal 2SE (internal precision): pit crosscutting epoxy and/or secondary phase

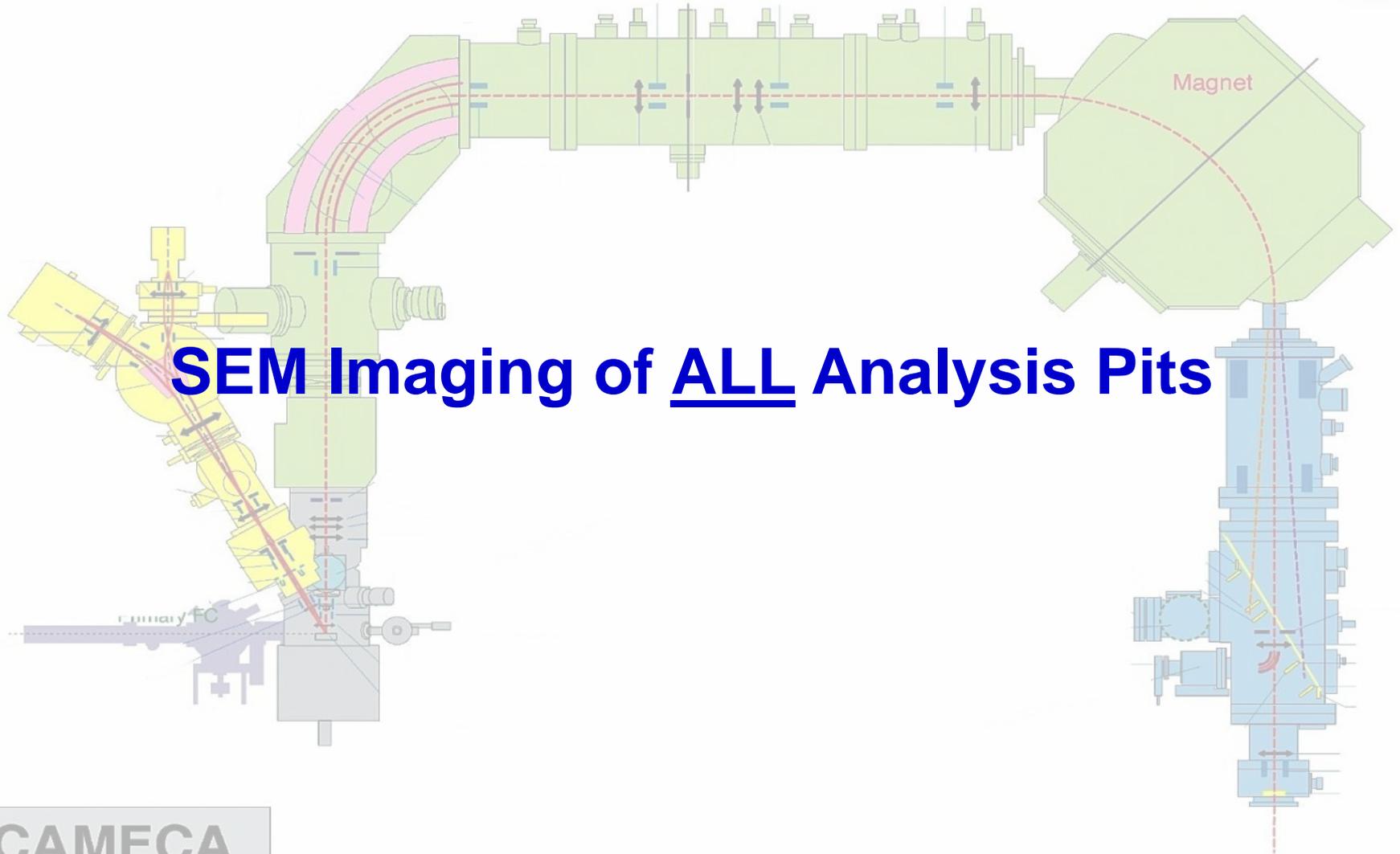
low ¹⁶O count rate, low yield: sample porosity, pit crosscutting epoxy



Data plotting outside the red dashed lines (yield <97% or >103% of the yield of the bracketing standards) were excluded, These pits likely contain a higher percentage of organics or are irregular (sample porosity, cavities, cracks, secondary phases).



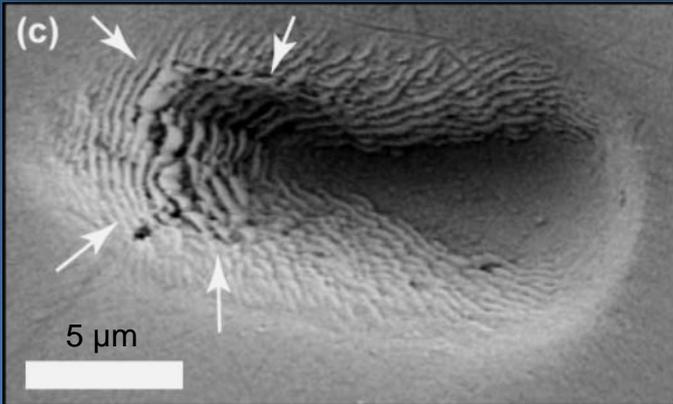
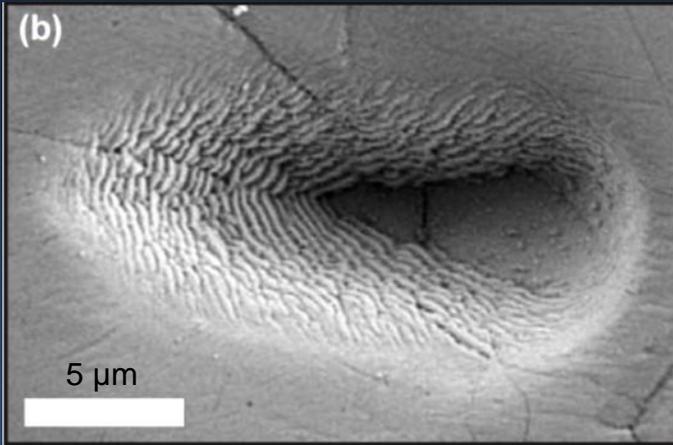
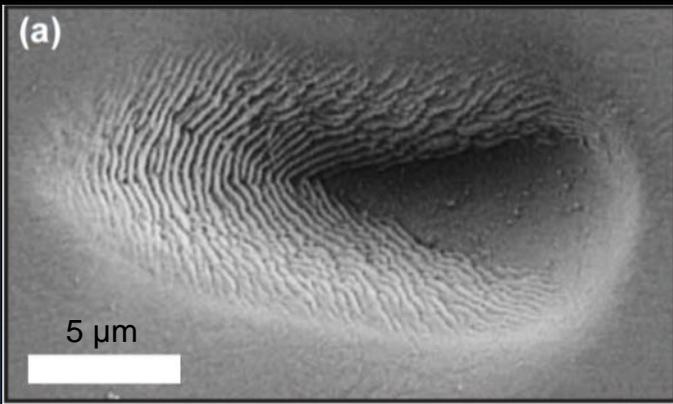
Data from pits with a yield of <97% or >103% of the yield in the bracketing standards were excluded. The remaining data show no correlation between yield and measured $\delta^{18}\text{O}$. The $\delta^{18}\text{O}$ values are corrected for instrumental drift, but not converted to the SMOW or PDB scale.



CAMECA

IMS 1280

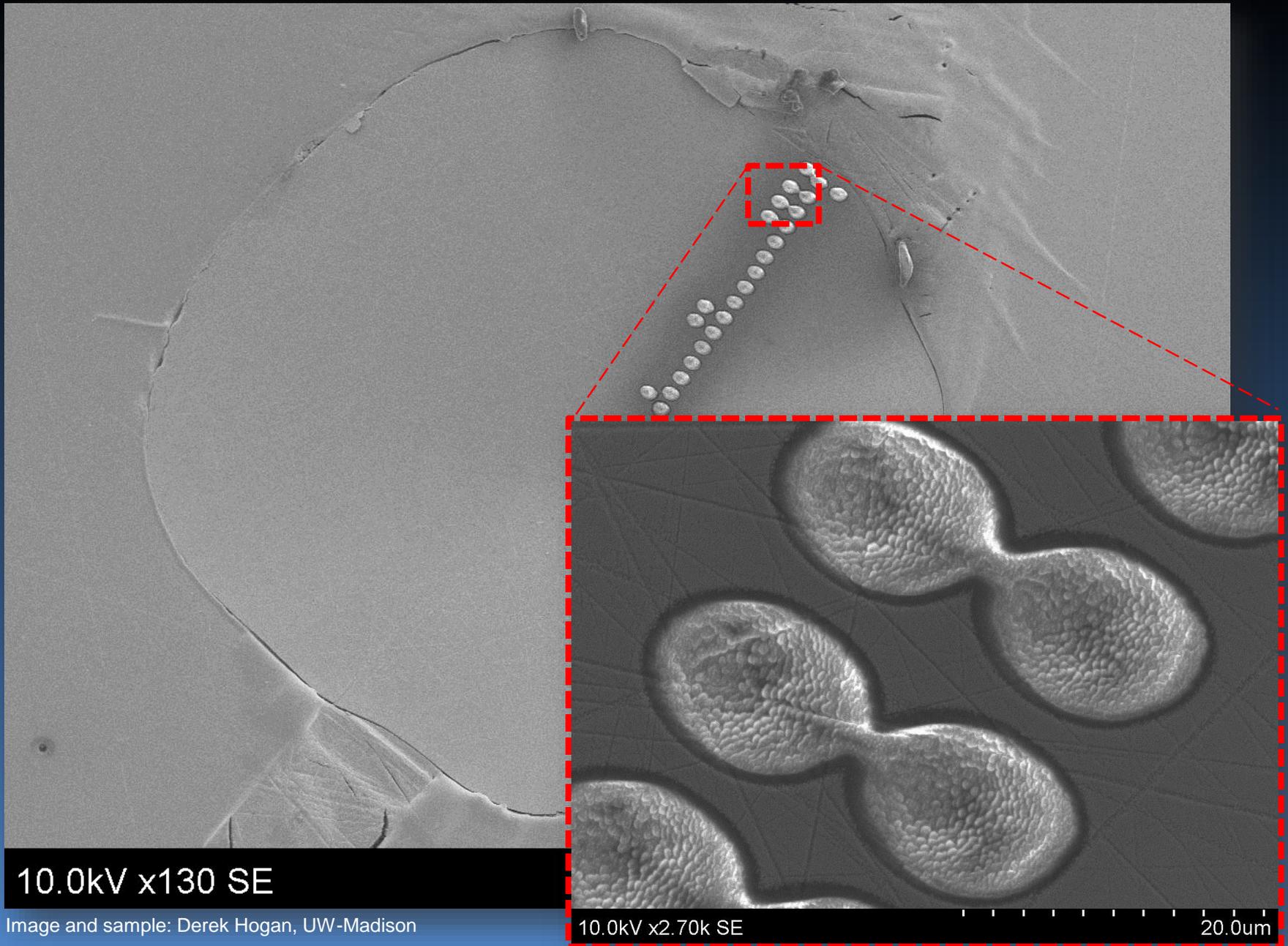
Examples of 'regular' and 'irregular' ion microprobe pits in zircon following $\delta^{18}\text{O}$ analysis



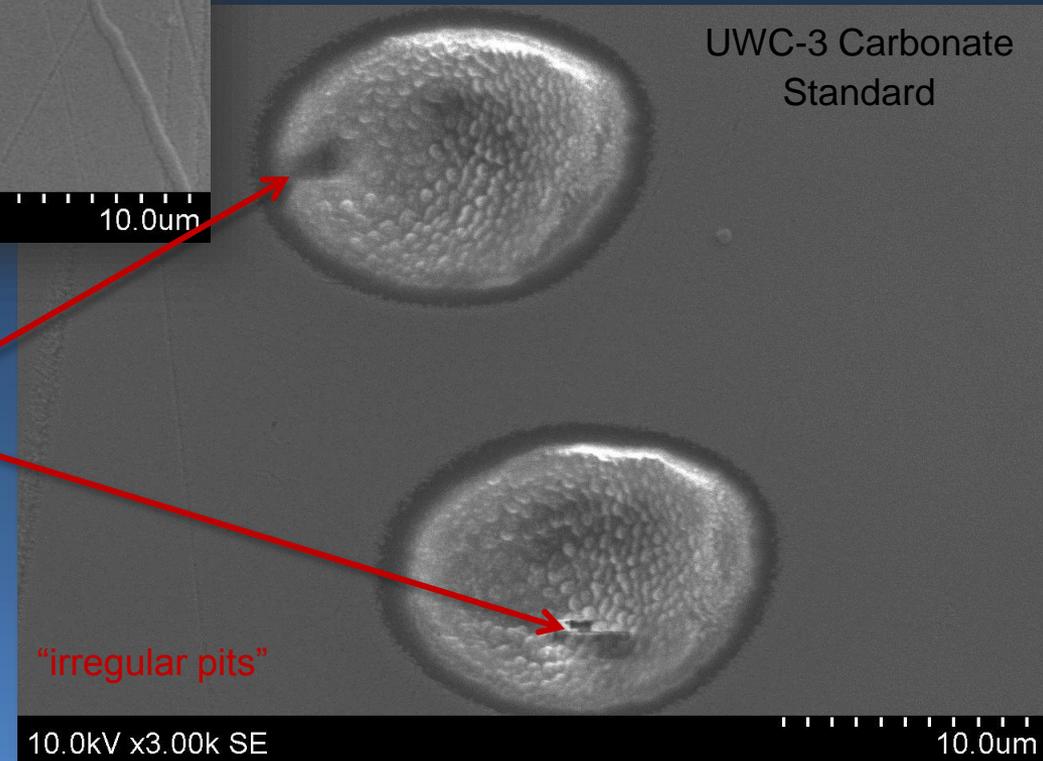
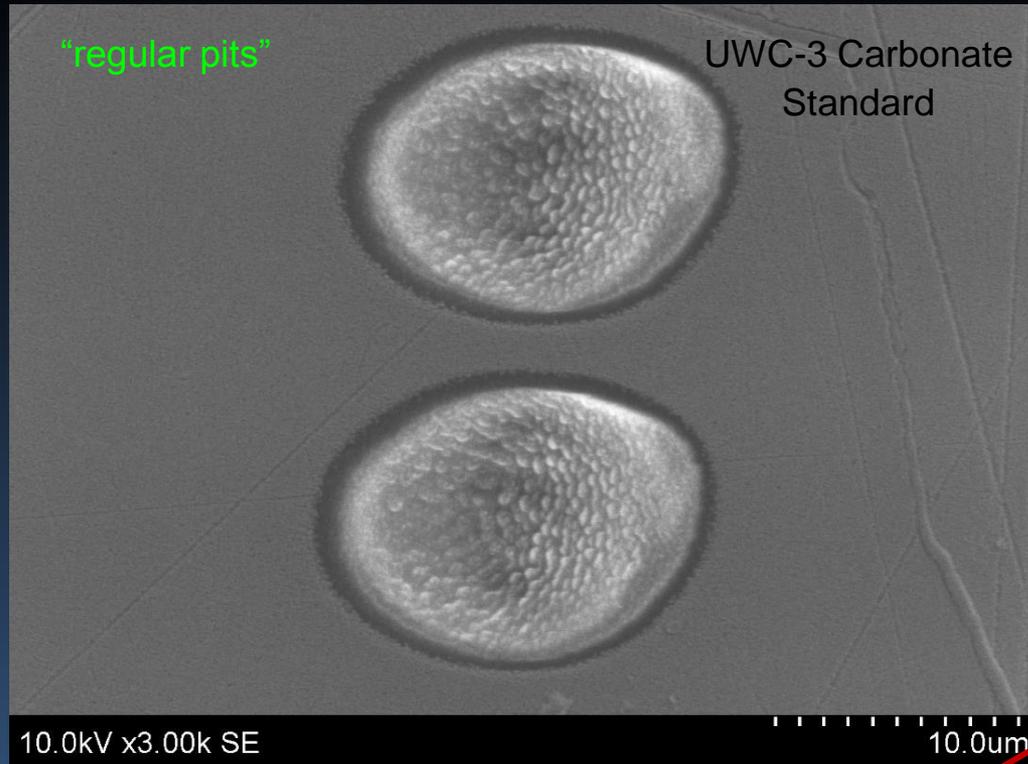
- (a) '**Regular**' pit, showing slight asymmetry due to inclination of primary beam
- (b) '**Irregular**' pit with through-going cracks, visible in the crater walls and floor
- (c) '**Irregular**' pit with a circular 'cavity' at the left side (defined by arrows). The analysis hit a mineral inclusion. Preferential sputtering of the inclusion is thought to have caused this feature. Pits are approximately 2-3 μm in depth.

It is tempting to accept data from 'irregular' pits. Such features often have no measurable affect on isotope ratio, however non-systematic and sometimes large shifts in measured $\delta^{18}\text{O}$ (up to +12‰ reported by Cavosie et al., 2005) demonstrate the importance to describe and evaluate 'irregular' pits.

Evaluation of SIMS analysis pits by SEM: Otolith



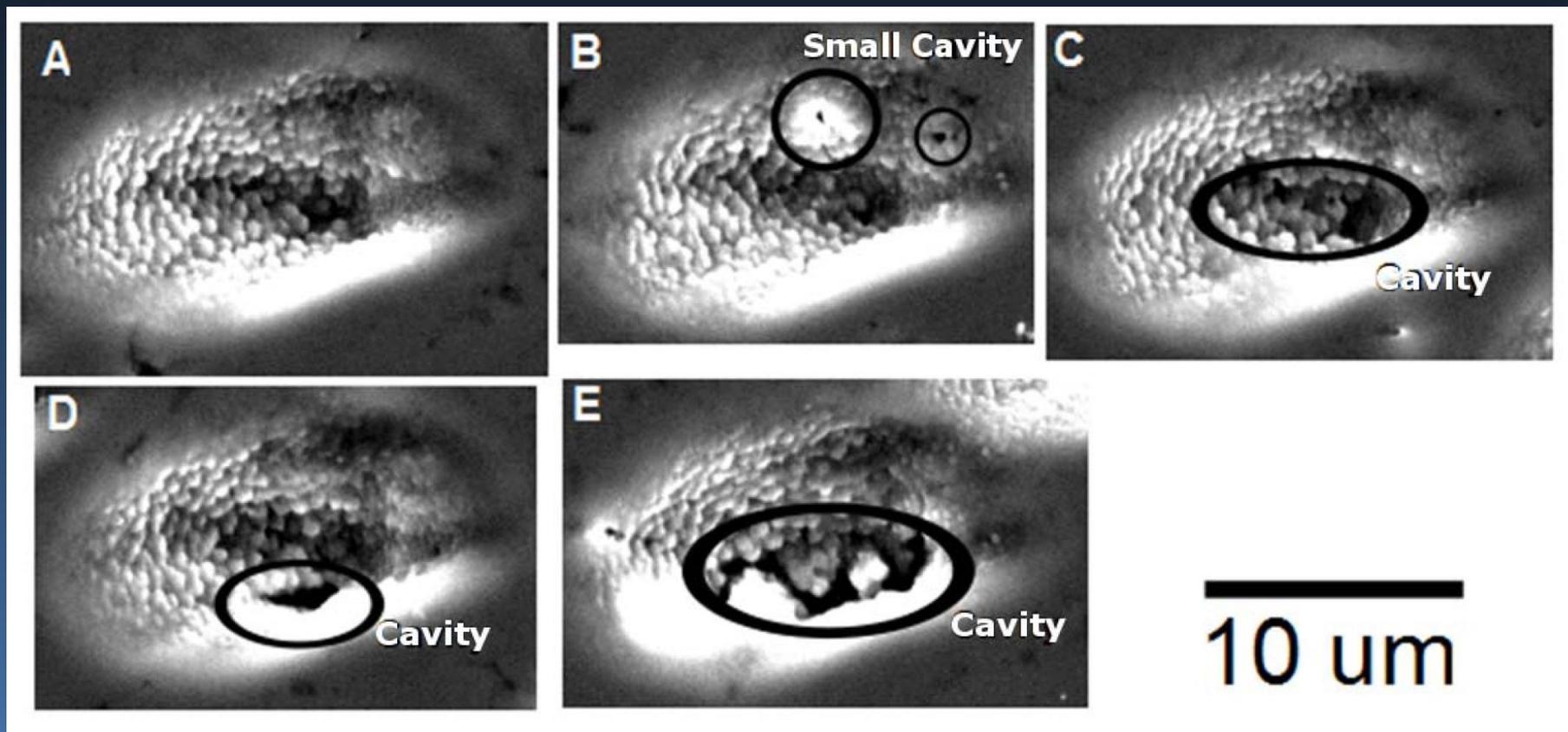
Evaluation of SIMS analysis pits by SEM: UWC-3 carbonate STD



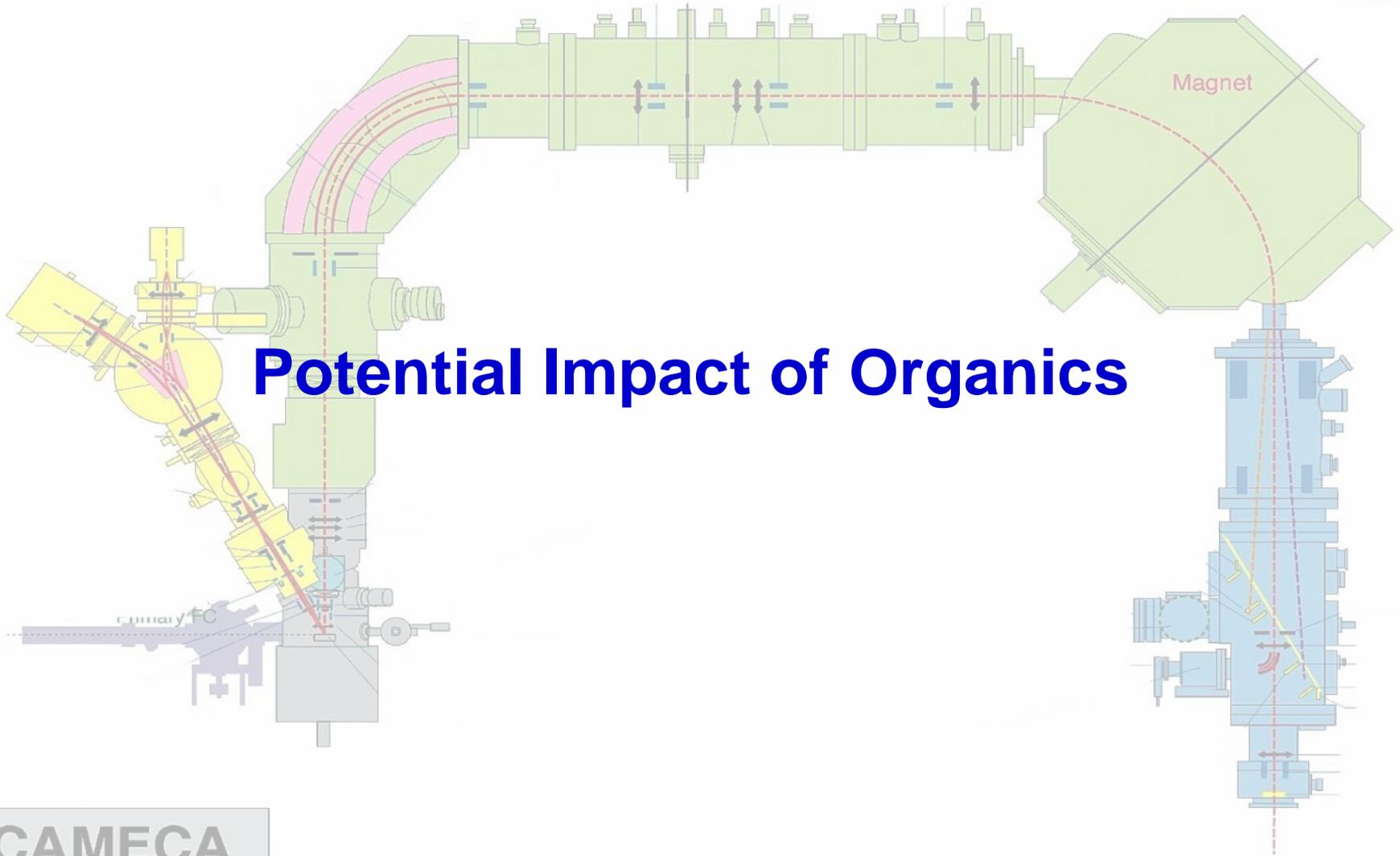
cavities and/or inclusions
data from these pits should not be used

Evaluation of SIMS analysis pits by SEM: Nautilus shell (prismatic nacre)

Regular and irregular pits in the prismatic aragonite shell

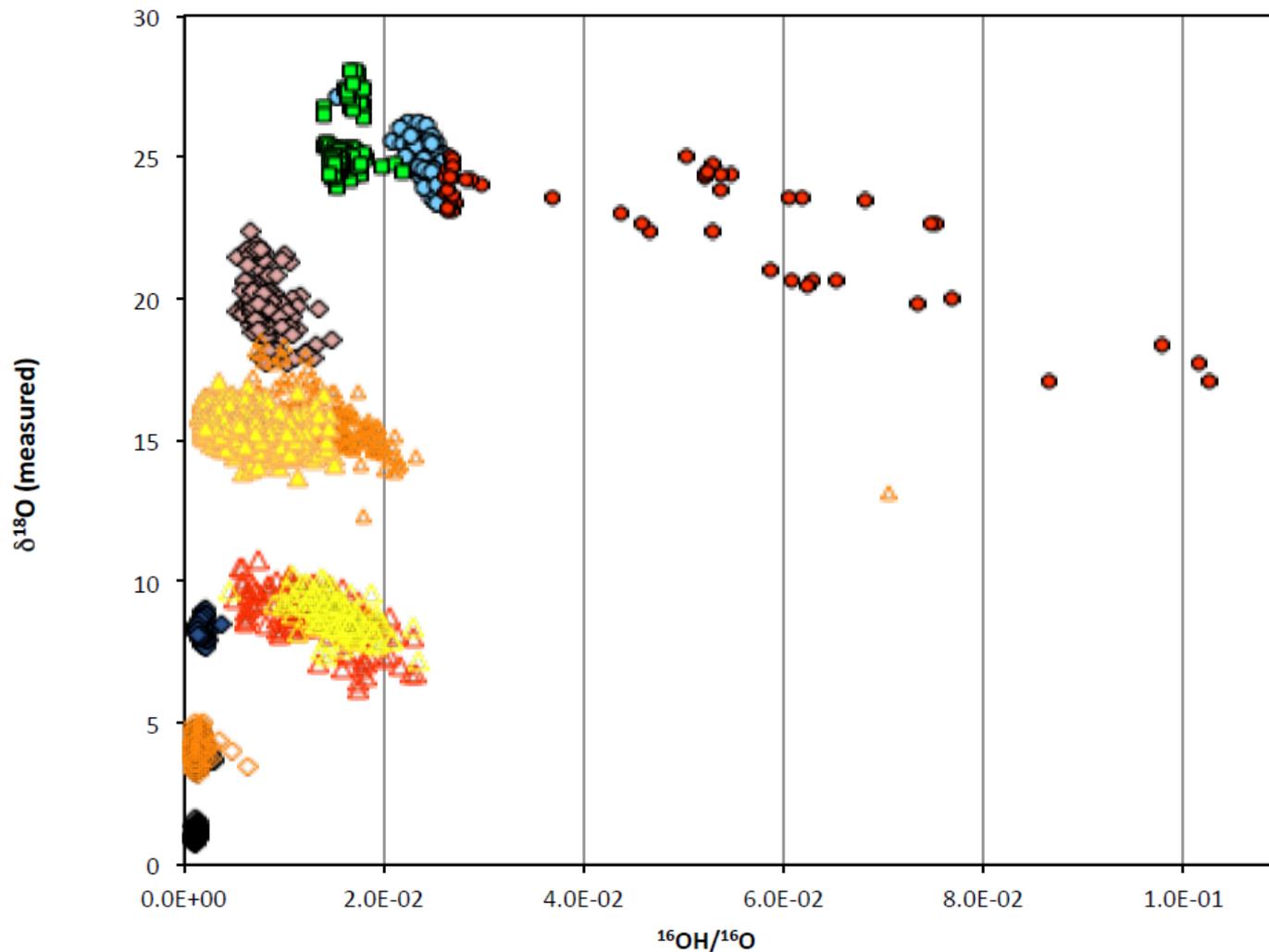


Linzmeier et al., in prep.

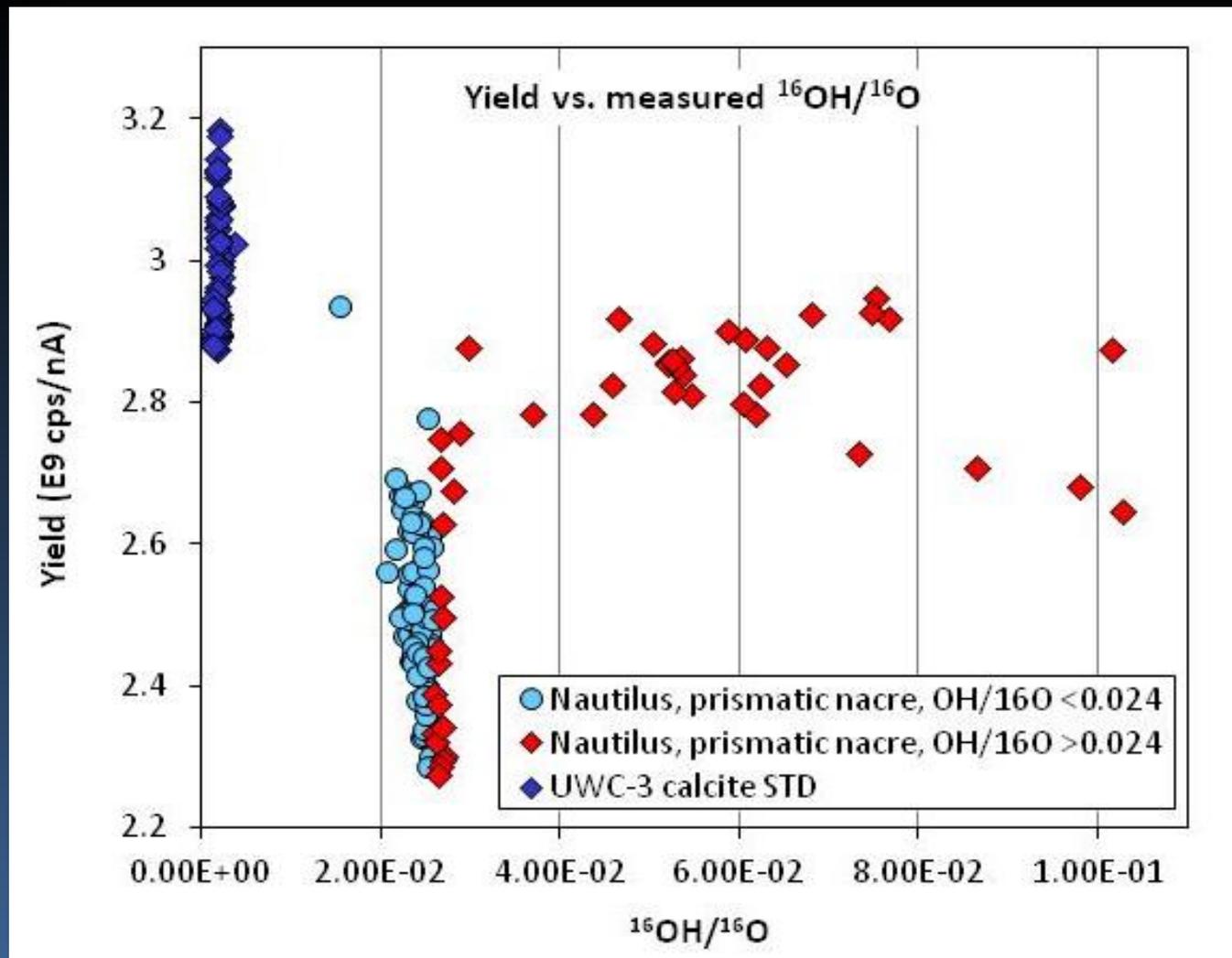


CAMECA

IMS 1280

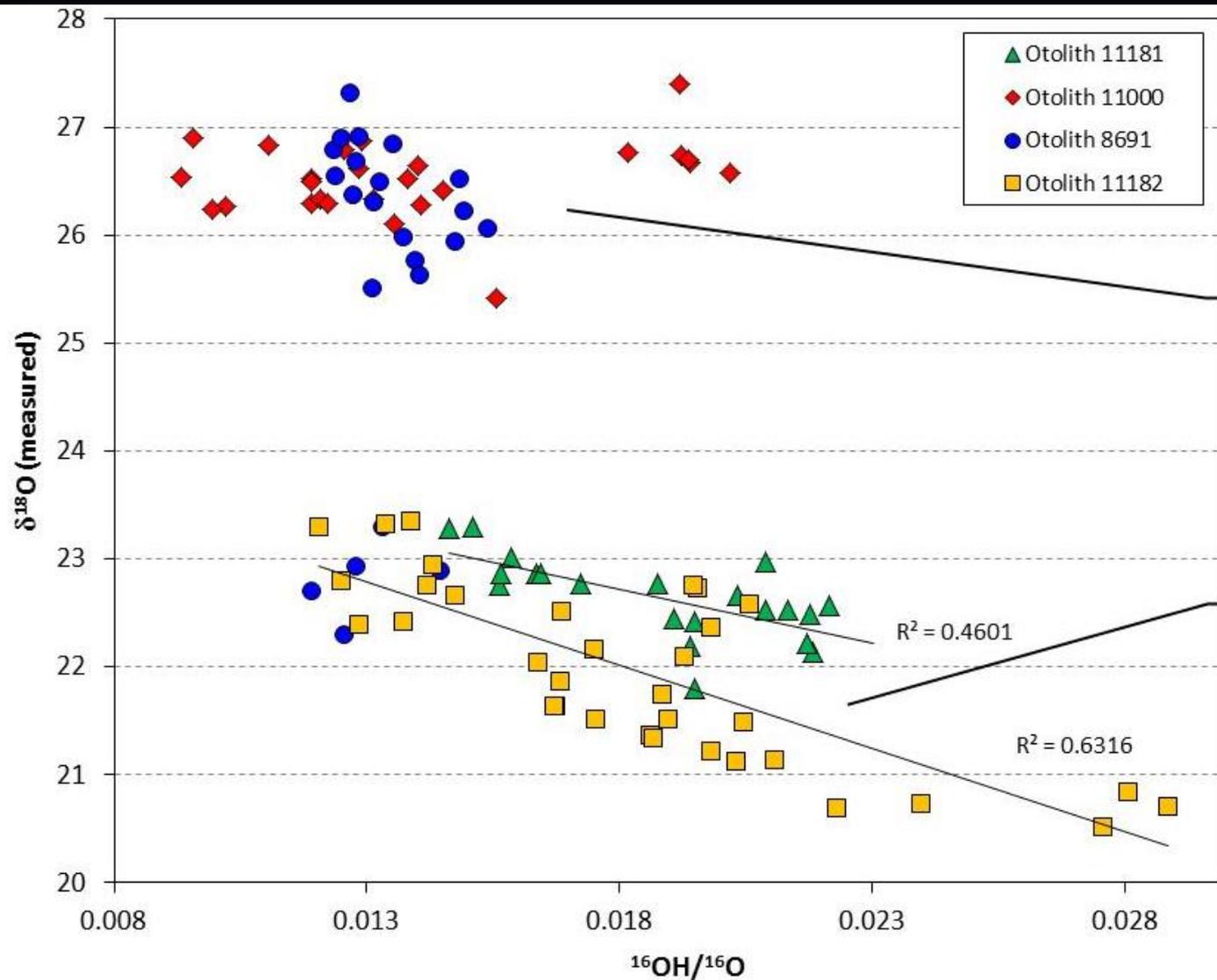


- | | |
|--|--|
| ● Nautilus, prismatic nacre, OH/16O <0.024 | ● Nautilus, prismatic nacre, OH/16O >0.024 |
| ■ sheeted nacre (bivalve) | ◇ Planktonic Forams, ODP 690 |
| ◆ UWC-3 Standard | △ Speleothem SO-38 |
| ◇ UWC-3 spel | ▲ Speleothem 2-20 |
| △ Speleothem BW-1 chips1-4 | ▲ Speleothem BW-1 chips15-18 |
| ◆ UWC-3 BW-1 chips1-4 | ◆ UWC-3 BW-1 chips15-18 |



High $^{16}\text{OH}/^{16}\text{O}$ ratios indicate the presence of H, presumably organic material, in the analysis pit. The yield in the nonporous standard (UWC-3, coarse crystalline calcite) is about 10% higher than in the porous nautilus shell. Highest yields in the nautilus shell are observed in domains with a high $^{16}\text{OH}/^{16}\text{O}$ signal (or a high proportion of organics, respectively).

Removal of organics: Sample roasting (Example: Otoliths)

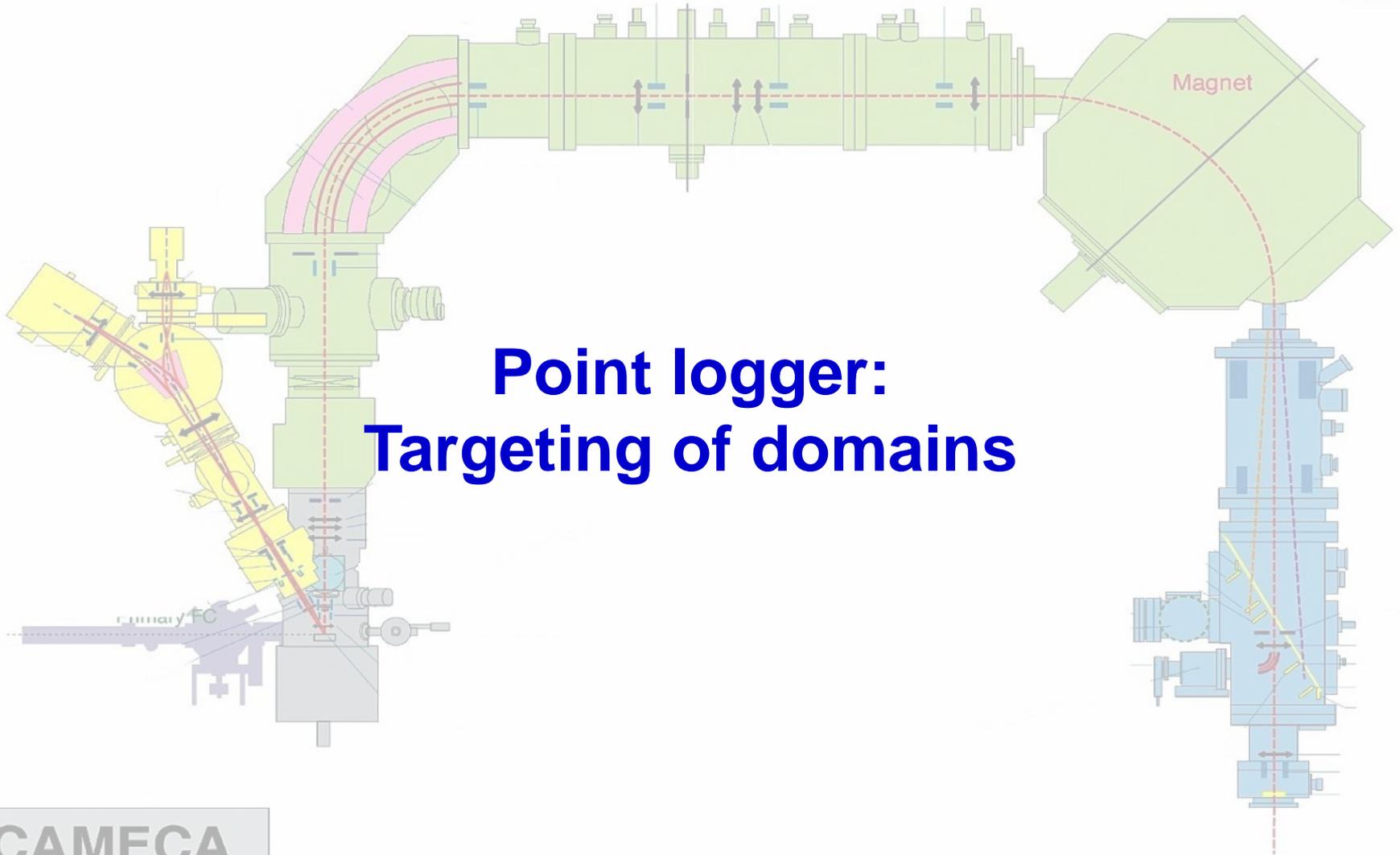


These otoliths represent two different rivers/water masses. They are smaller than the other two samples, however, they were roasted for a longer period of time (2 h at 262°C).

These otoliths represent the same river/water mass. They are larger than the other two samples, however, they were roasted for a shorter period of time (30 min at 262°C).

They may have disintegrated when roasted for a longer period. Chemical treatment?

Biocarbonates containing significant amount of organics (e.g. otoliths, bivalves, mollusks) should be roasted or chemically treated to remove organics. However, this may cause disintegration of the sample, therefore, “practice”- samples should be used to evaluate the best procedure.

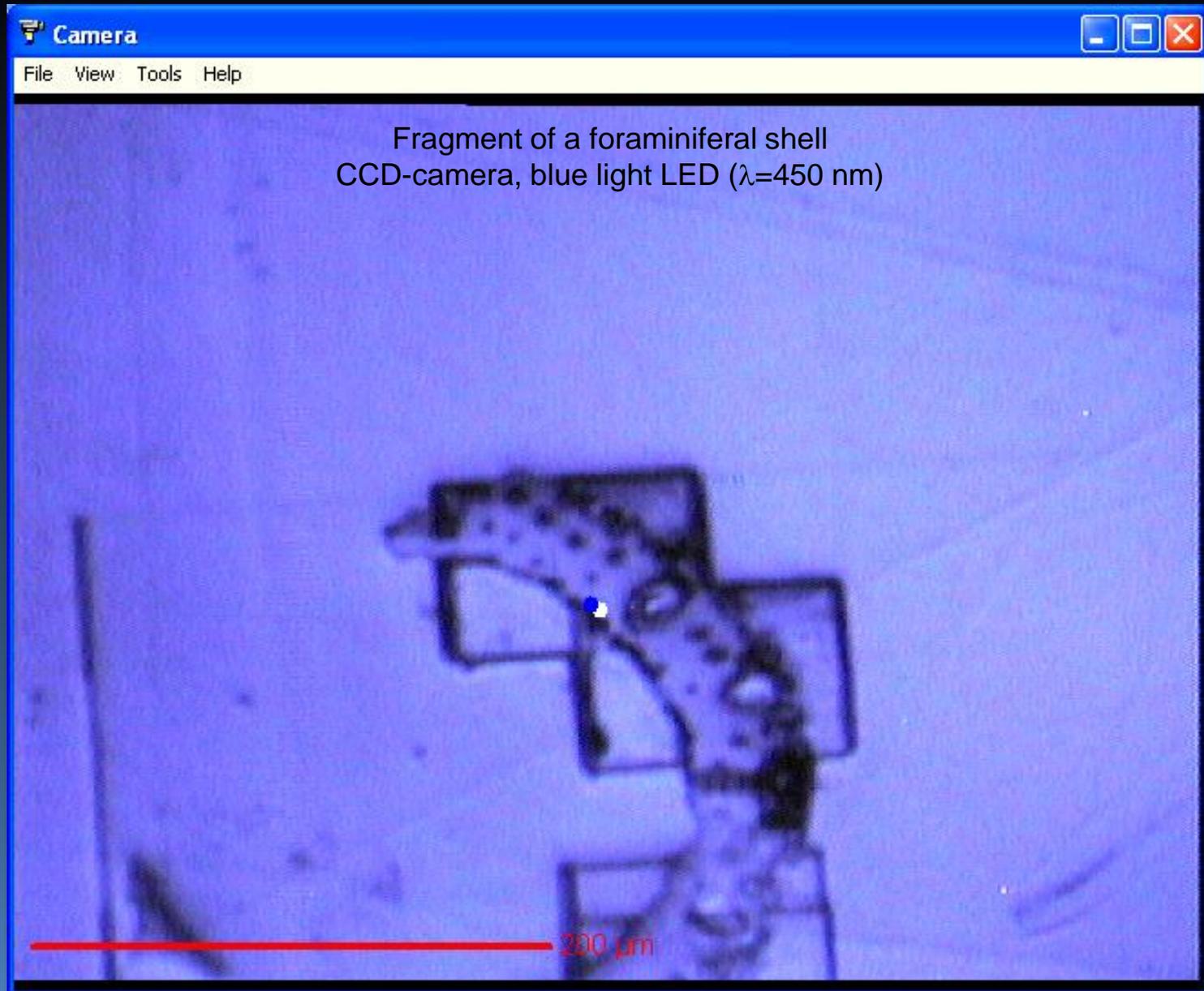


Point logger: Targeting of domains

CAMECA

IMS 1280

Sample view by the built-in CCD camera



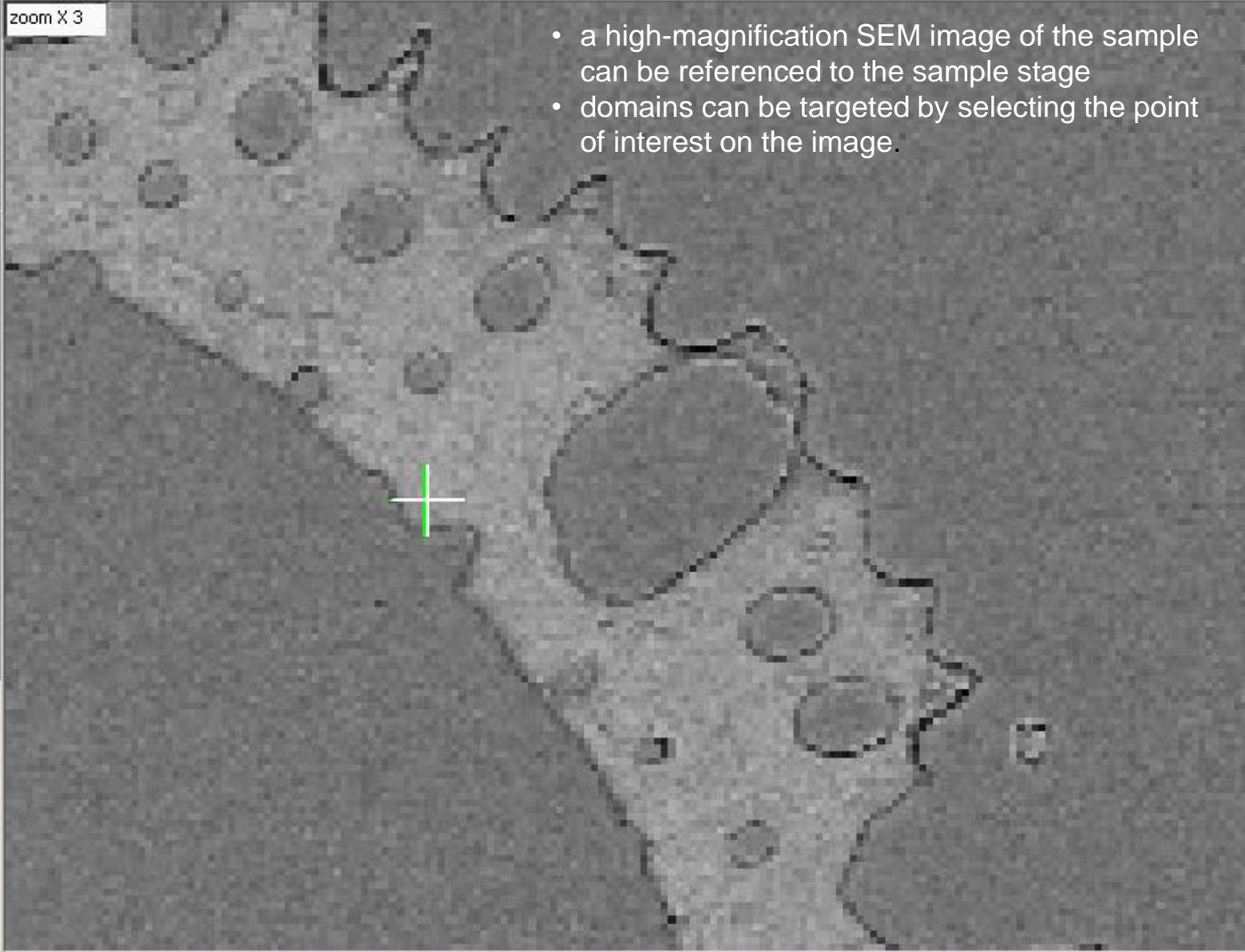
Point-Logger

POINT LOGGER v1.151 : *1208-1.jpg

load image...
Algnmt
quit

Display
mouse
zoom
algnmt
target
pixel
641
782
holder
-377
935
config...

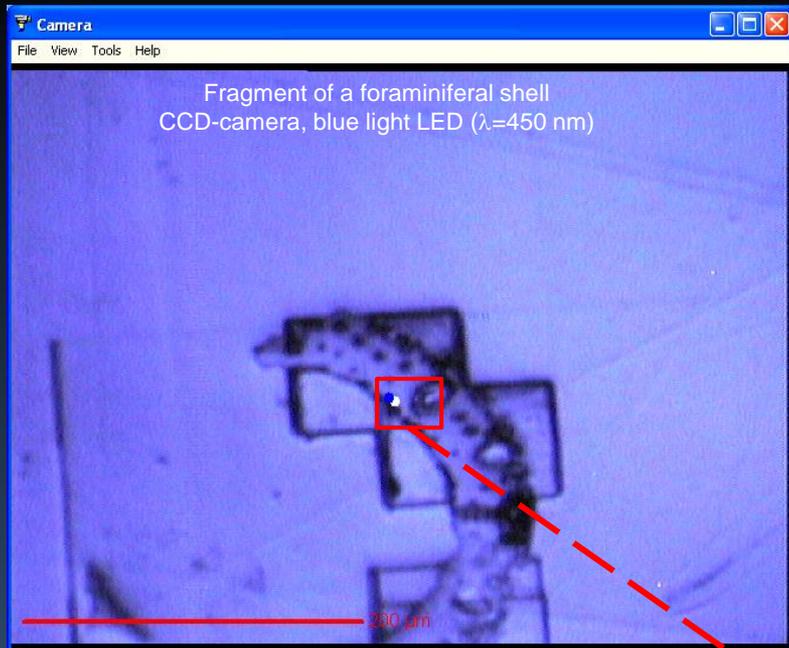
zoom X 3



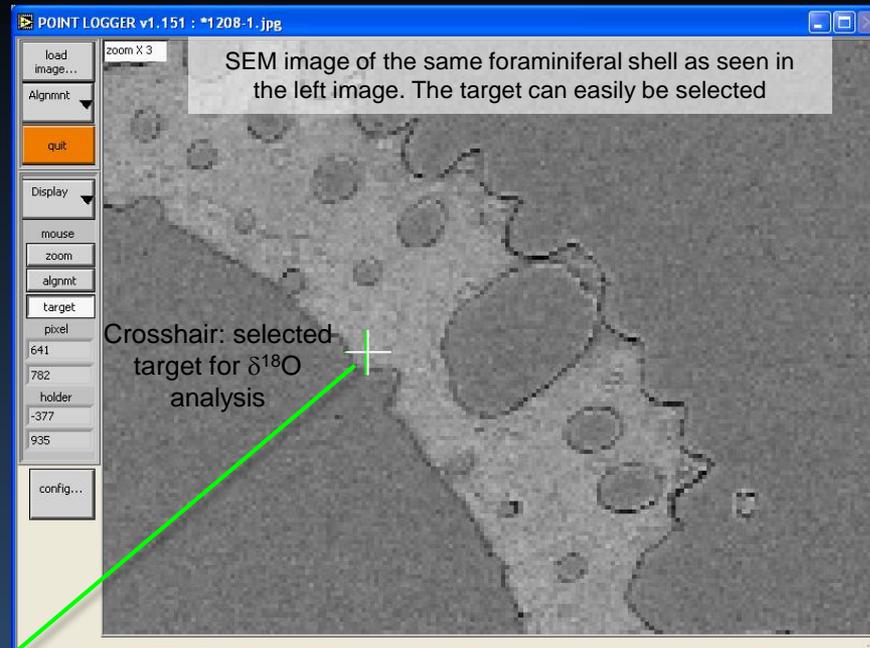
The image shows a scanning electron microscope (SEM) image of a sample. The image is grayscale and shows a complex, porous structure with many small, circular features. A green crosshair is overlaid on the image, indicating a point of interest. The interface includes a menu bar at the top with 'POINT LOGGER v1.151 : *1208-1.jpg' and standard window controls. On the left, there is a vertical toolbar with buttons for 'load image...', 'Algnmt', 'quit', 'Display', 'mouse', 'zoom', 'algnmt', 'target', 'pixel', '641', '782', 'holder', '-377', '935', and 'config...'. A 'zoom X 3' label is visible in the top left corner of the image area.

- a high-magnification SEM image of the sample can be referenced to the sample stage
- domains can be targeted by selecting the point of interest on the image.

During analysis, the sample can be seen by an optical microscope/CCD-camera. This representative image demonstrates the aiming-process (primary beam hits at blue marker). Typically this system is used for sample navigation and aiming.

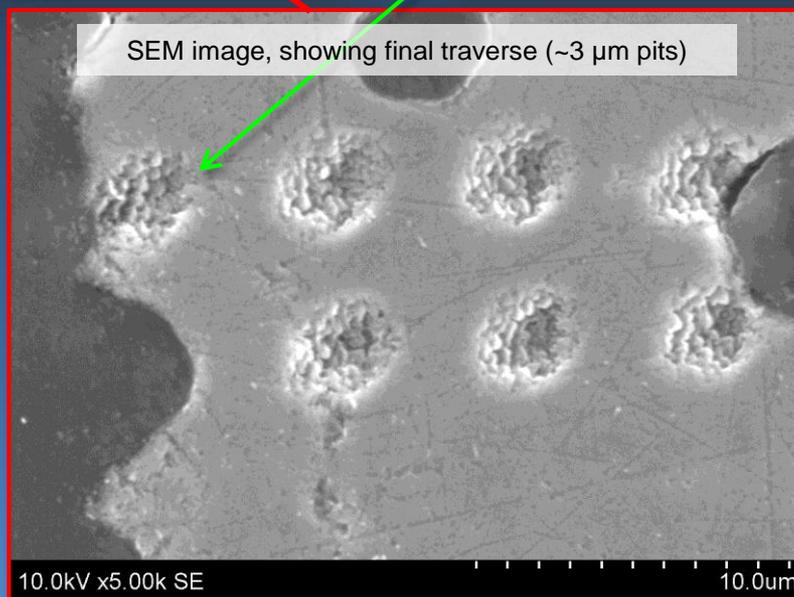


For some types of samples, the resolution of the optical microscope (left image) is insufficient for precise aiming. We can upload SEM images (field of view ~500 μm) and align them to the sample stage. Subsequently, targets can be selected using the more detailed/higher resolution SEM image.

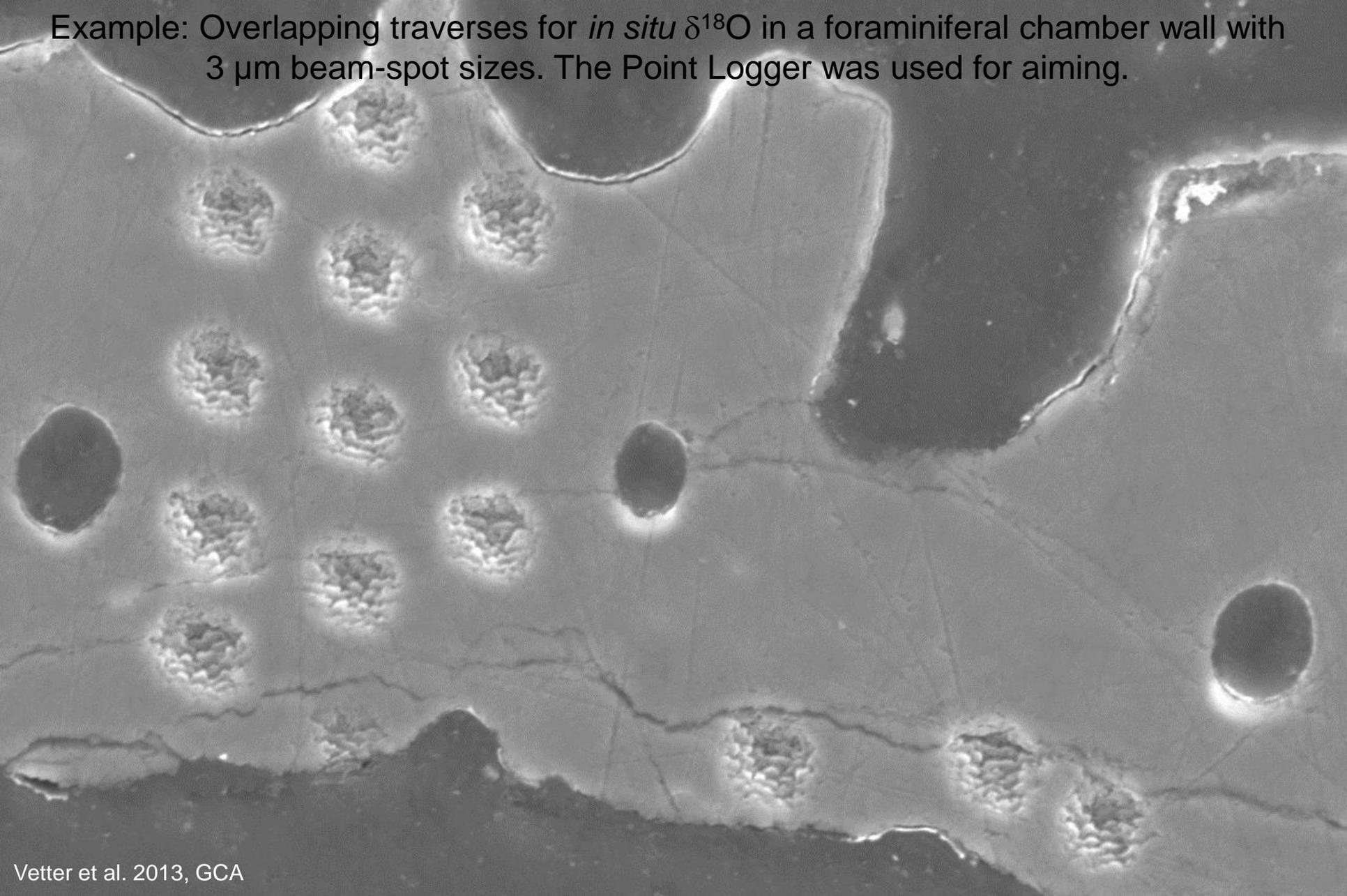


Point Logger

Using SEM images for precise aiming



Example: Overlapping traverses for *in situ* $\delta^{18}\text{O}$ in a foraminiferal chamber wall with 3 μm beam-spot sizes. The Point Logger was used for aiming.



Vetter et al. 2013, GCA

10.0kV x2.70k SE

20.0um

Thank you!

